

3-Phase Brushless Motor Driver

Check for Samples: [DRV3211-Q1](#)

FEATURES

- 3-Phase Pre-drivers for N-channel MOS Field Effect Transistors (MOSFETs)
- Pulse Width Modulation (PWM) Frequency up to 20 kHz
- Fault Diagnostics
- Charge Pump
- Phase Comparators
- Phase Monitoring Sample and Hold Op-Amps
- Central Processing Unit (CPU) Reset Generator
- Serial Port I/F (SPI)
- Motor Current Sense
- 80-pin HTQFP
- 5-V Regulator

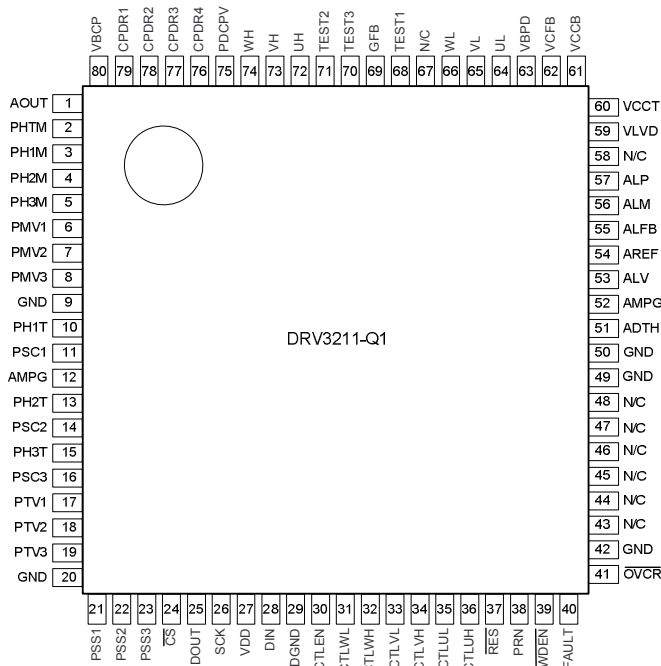
APPLICATIONS

- Automotive

PINOUT

DESCRIPTION

The DRV3211-Q1 device is a field effect transistor (FET) pre-driver designed for 3-phase motor control and its application such as an oil pump or a water pump. It is equipped with three high-side pre-FET drivers and three low-side drivers which are controlled by an external microcontroller (MCU). The power for the high side is supplied by a charge pump and no bootstrap cap is needed. For commutation, this integrated circuit (IC) sends a conditional motor drive signal and output to the MCU. Diagnostics provide undervoltage, overvoltage, overcurrent, overtemperature and power bridge faults. The motor current can be measured using an integrated current sense amplifier and comparator in a battery common-mode range, which allows the motor current to be used in a high-side current sense application. Gain is attained by external resistors. If the MCU does not have enough bandwidth, the phase monitoring sample and hold amplifiers can hold phase information until the MCU is ready to process it. The pre-driver and other internal settings can be configured through the SPI interface.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

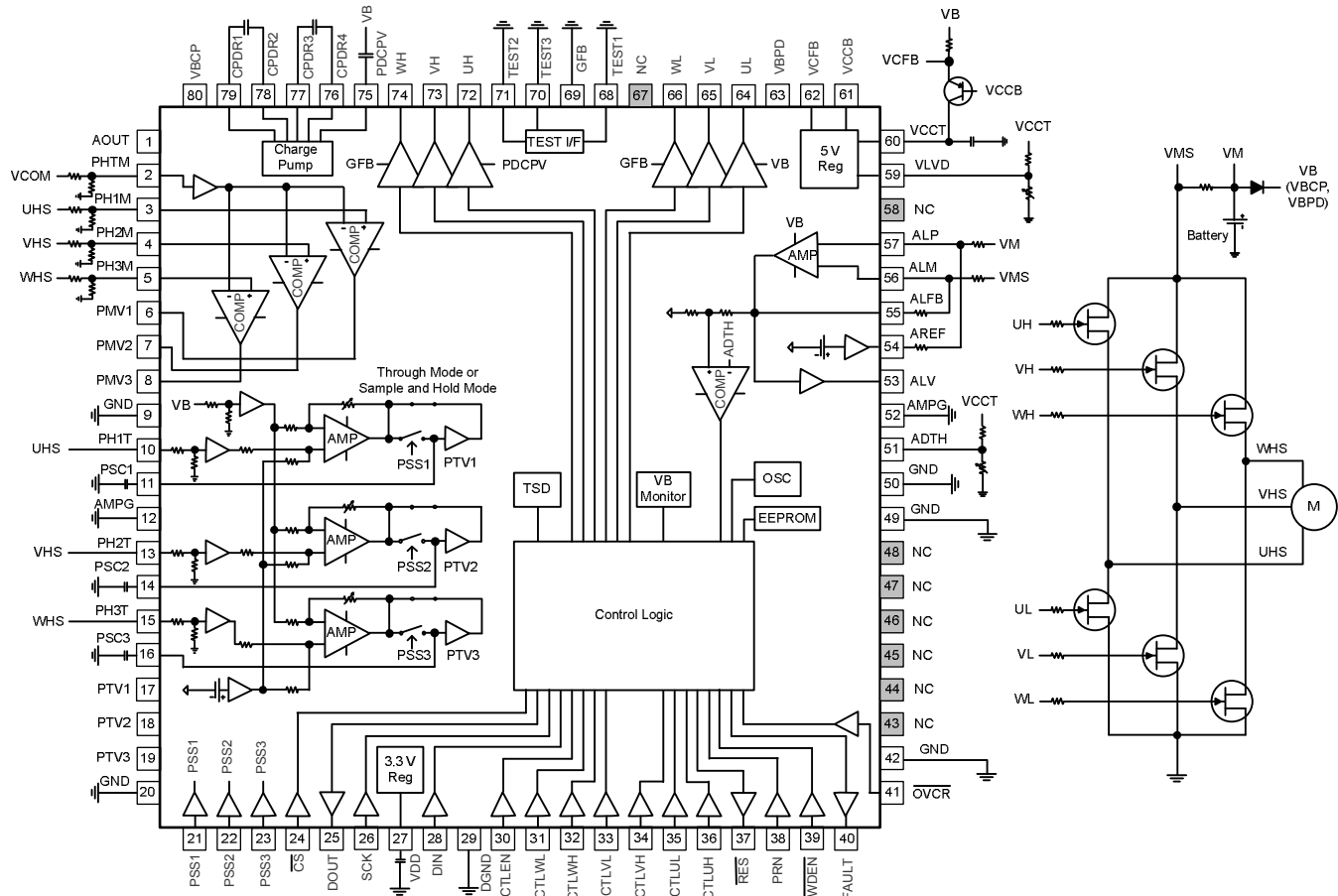
ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PIN FUNCTIONS

NO.	PIN		MAX RATING	FUNCTION
	NAME	TYPE		
1	AOUT	O	–0.3–6 V	Test mode output
2	PHTM	I	–1–40 V	Phase comparator reference input
3	PH1M	I	–1–40 V	Phase comparator input
4	PH2M	I	–1–40 V	Phase comparator input
5	PH3M	I	–1–40 V	Phase comparator input
6	PMV1	O	–0.3–6 V	Phase comparator output
7	PMV2	O	–0.3–6 V	Phase comparator output
8	PMV3	O	–0.3–6 V	Phase comparator output
9, 20, 42, 49, 50	GND	I	–0.3–0.3 V	GND
10	PH1T	I	–2–40 V	Phase amplifier input
11	PSC1	O	–0.3–6 V	Sample and hold filter output
12	AMPG	I	–0.3–0.3 V	Quiet GND
13	PH2T	I	–2–40 V	Phase amplifier input
14	PSC2	O	–0.3–6 V	Sample and hold filter output
15	PH3T	I	–2–40 V	Phase amplifier input
16	PSC3	O	–0.3–6 V	Sample and hold filter output
17	PTV1	O	–0.3–6 V	Phase amplifier output
18	PTV2	O	–0.3–6 V	Phase amplifier output
19	PTV3	O	–0.3–6 V	Phase amplifier output
21	PSS1	I	–0.3–6 V	Sample and hold control signal input
22	PSS2	I	–0.3–6 V	Sample and hold control signal input
23	PSS3	I	–0.3–6 V	Sample and hold control signal input
24	$\overline{\text{CS}}$	I	–0.3–6 V	SPI chip select
25	DOUT	O	–0.3–6 V	SPI data output
26	SCK	I	–0.3–6 V	SPI clock
27	VDD	O	–0.3–3.6 V	Digital supply output
28	DIN	I	–0.3–6 V	SPI data input
29	DGND	I	–0.3–0.3 V	Digital GND
30	CTLEN	I	–0.3–6 V	Pre-driver parallel enable input
31	CTLWL	I	–0.3–6 V	Pre-driver parallel input
32	CTLWH	I	–0.3–6 V	Pre-driver parallel input
33	CTLVL	I	–0.3–6 V	Pre-driver parallel input
34	CTLVH	I	–0.3–6 V	Pre-driver parallel input
35	CTLUL	I	–0.3–6 V	Pre-driver parallel input
36	CTLUH	I	–0.3–6 V	Pre-driver parallel input
37	$\overline{\text{RES}}$	O	–0.3–6 V	Reset output
38	PRN	I	–0.3–6 V	Pulse input
39	$\overline{\text{WDEN}}$	I	–0.3–6 V	Reset generator enable input
40	FAULT	O	–0.3–6 V	Diagnosis output
41	$\overline{\text{OVCR}}$	I	–0.3–6 V	Over current reset input
43-48, 58, 67	N/C	—	—	Not connected
51	ADTH	I	–0.3–6 V	Motor overcurrent threshold input

PIN FUNCTIONS (continued)

PIN			MAX RATING	FUNCTION
NO.	NAME	TYPE		
52	AMPG	I	–0.3–0.3 V	Quiet GND
53	ALV	O	–0.3–6 V	Motor current sense amp output
54	AREF	O	–0.3–40 V	Motor current sense reference output
55	ALFB	O	–0.3–40 V	Motor current sense amp feedback
56	ALM	I	–0.3–40 V	Motor current sense amp negative input
57	ALP	I	–0.3–40 V	Motor current sense amp positive input
59	VLVD	I	–0.3–6 V	V _{CC} undervoltage threshold input
60	VCCT	I	–0.3–6 V	V _{CC} supply input
61	VCCB	O	–0.3–40 V	V _{CC} regulator base drive for PNP external transistor
62	VCFB	I	–0.3–40 V	V _{CC} regulator current sense input
63	VBPD	I	–0.3–40 V	VB input
64	UL	O	–0.3–20 V	Pre-driver output
65	VL	O	–0.3–20 V	Pre-driver output
66	WL	O	–0.3–20 V	Pre-driver output
68	TEST1	I	–0.3–6 V	Test input
69	GFB	I	–0.3–0.3 V	Power GND
70	TEST3	I	–0.3–20 V	Test input
71	TEST2	I	–0.3–6 V	Test input
72	UH	O	–0.3–40 V	Pre-driver output
73	VH	O	–0.3–40 V	Pre-driver output
74	WH	O	–0.3–40 V	Pre-driver output
75	PDCPV	O	–0.3–40 V	Charge pump output
76	CPDR4	O	–0.3–40 V	Charge pump output
77	CPDR3	O	–0.3–40 V	Charge pump output
78	CPDR2	O	–0.3–40 V	Charge pump output
79	CPDR1	O	–0.3–40 V	Charge pump output
80	VBCP	I	–0.3–4 0V	VB input

BLOCK DIAGRAM**Figure 1. Top Block Diagram****ABSOLUTE MAXIMUM RATINGS**

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNITS
ESD ⁽¹⁾					
ESD all pins	ESD performance of all pins to any other pin	HBM model	-2	2	kV
		CDM model	-500	500	V
TEMPERATURE					
T _A	Operating temperature range		-40	125	degree
T _J	Junction temperature		-40	150	degree
T _S	Storage temperature		-55	150	degree

(1) ESD testing is performed according to the ACE-Q100 standard.

THERMAL INFORMATION

THERMAL METRIC ⁽¹⁾		DRV3202-Q1	UNIT
		HTQP (80-PIN)	
θ_{JA}	Junction-to-ambient thermal resistance	23.0	°C/W
θ_{JCTop}	Junction-to-case (top) thermal resistance	7.5	
θ_{JB}	Junction-to-board thermal resistance	7.6	
Ψ_{JT}	Junction-to-top characterization parameter	0.2	
Ψ_{JB}	Junction-to-board characterization parameter	7.4	
θ_{JCbot}	Junction-to-case (bottom) thermal resistance	0.3	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, [SPRA953](#).

PRODUCT PREVIEW

SUPPLY VOLTAGE AND CURRENT

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
SUPPLY INPUT						
V_B	V_B Supply voltage		5.3	12	18	V
I_{VB}	V_B Operating current	$V_B = 5.3 \sim 18\text{ V}$, No PWM		20	35	mA

WATCHDOG

Description

The watchdog monitors the PRN signal and V_{CC} supply level and generates a reset to the MCU through the $\overline{\text{RES}}$ pin if the status of the PRN is not normal or the V_{CC} is lower than the specified threshold level. The watchdog can be disabled if WDEN is set high.

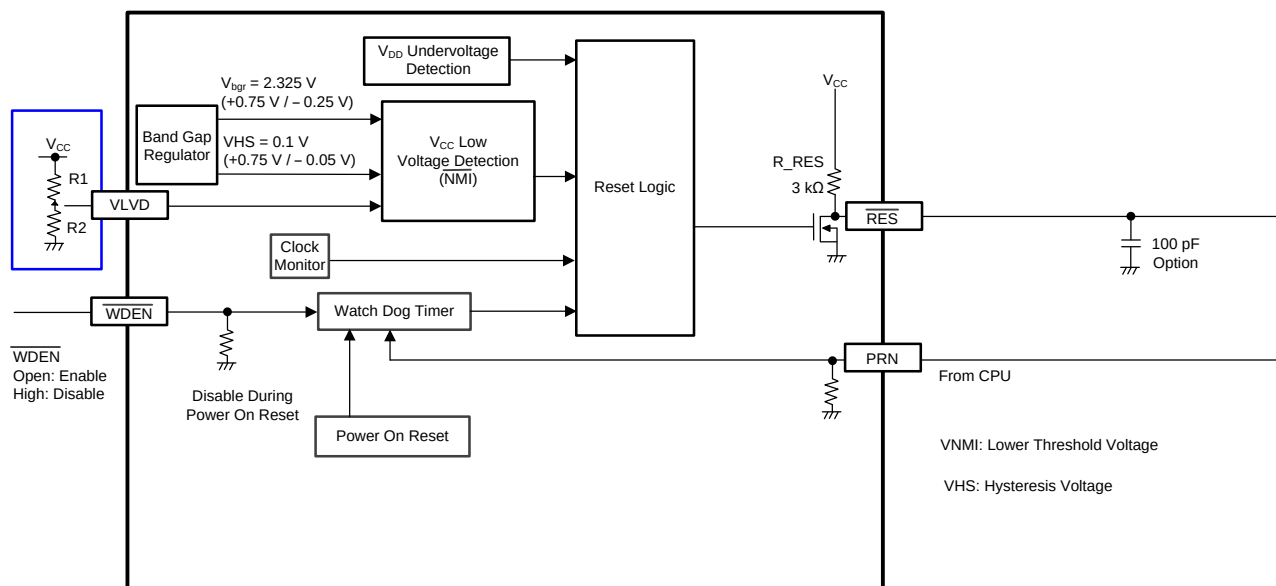


Figure 2. Watchdog Block Diagram

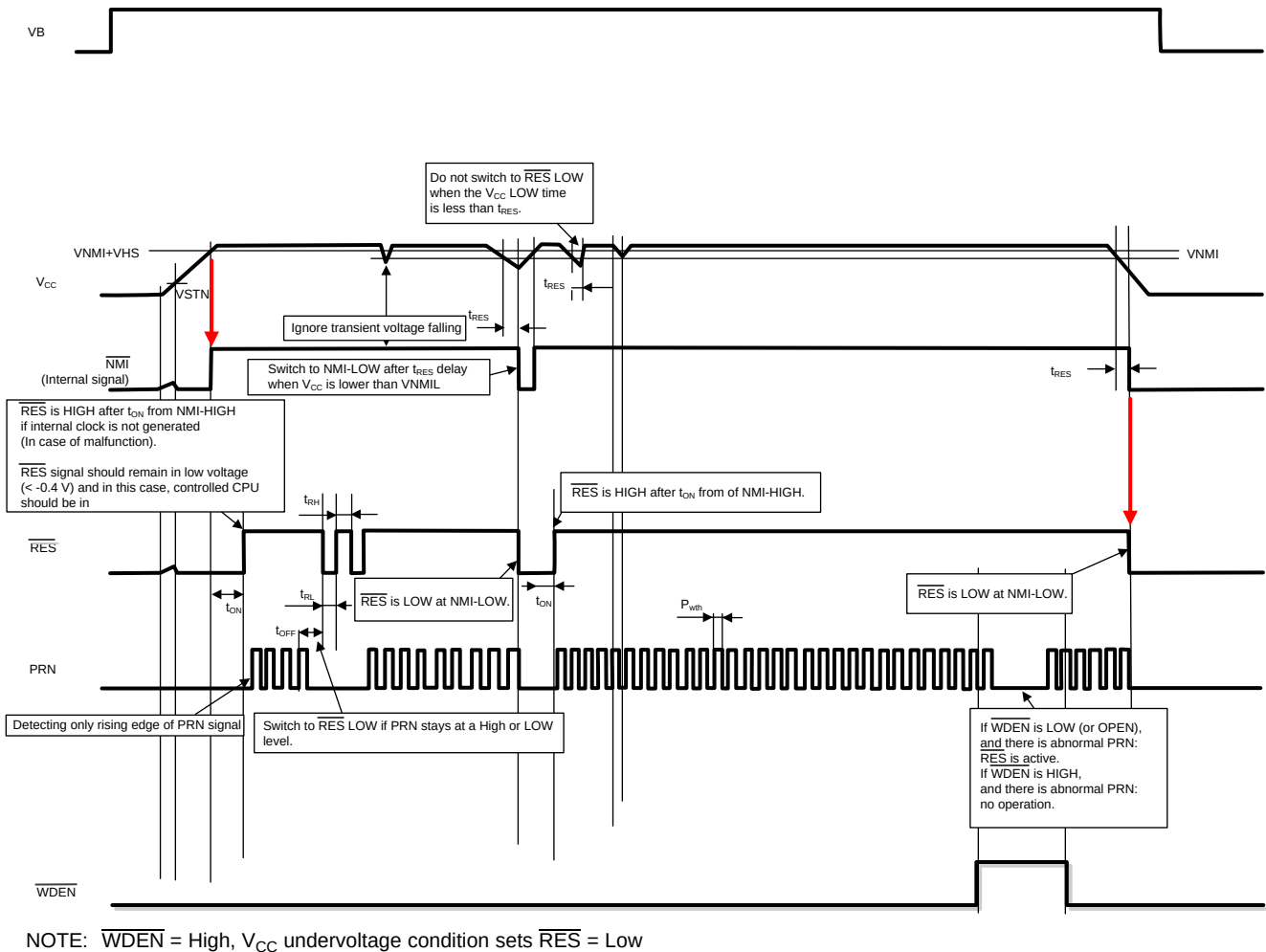


Figure 3. Watchdog Timing Chart

WATCHDOG ELECTRICAL CHARACTERISTICS⁽¹⁾

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER ⁽²⁾	CONDITIONS	MIN	TYP	MAX	UNITS
WATCHDOG					
VSTN	Function start V_{CC} voltage $\overline{RES}$	—	0.8	1.3	V
t_{ON}	Power-on time $\overline{RES}$	32	40	48	ms
t_{OFF}	Clock off reset time $\overline{RES}$	64	80	96	ms
t_{RL}	Reset pulse low time $\overline{RES}$	16	20	24	ms
t_{RH}	Reset pulse high time $\overline{RES}$	64	80	96	ms
t_{RES}	Reset delay time $\overline{RES}$	30	71.5	90	μs
P_{wth}	Pulse width PRN	200	—	—	ns

(1) The watchdog function is disabled and the timing parameters are invalid when the $\overline{WDEN}$ is at a high level.

(2) Specified by design

SERIAL PORT I/F

Description

The SPI is used to receive an input byte from CPU and to transmit an output byte to CPU. Four signals are utilized according to the timing chart of [Figure 4](#).

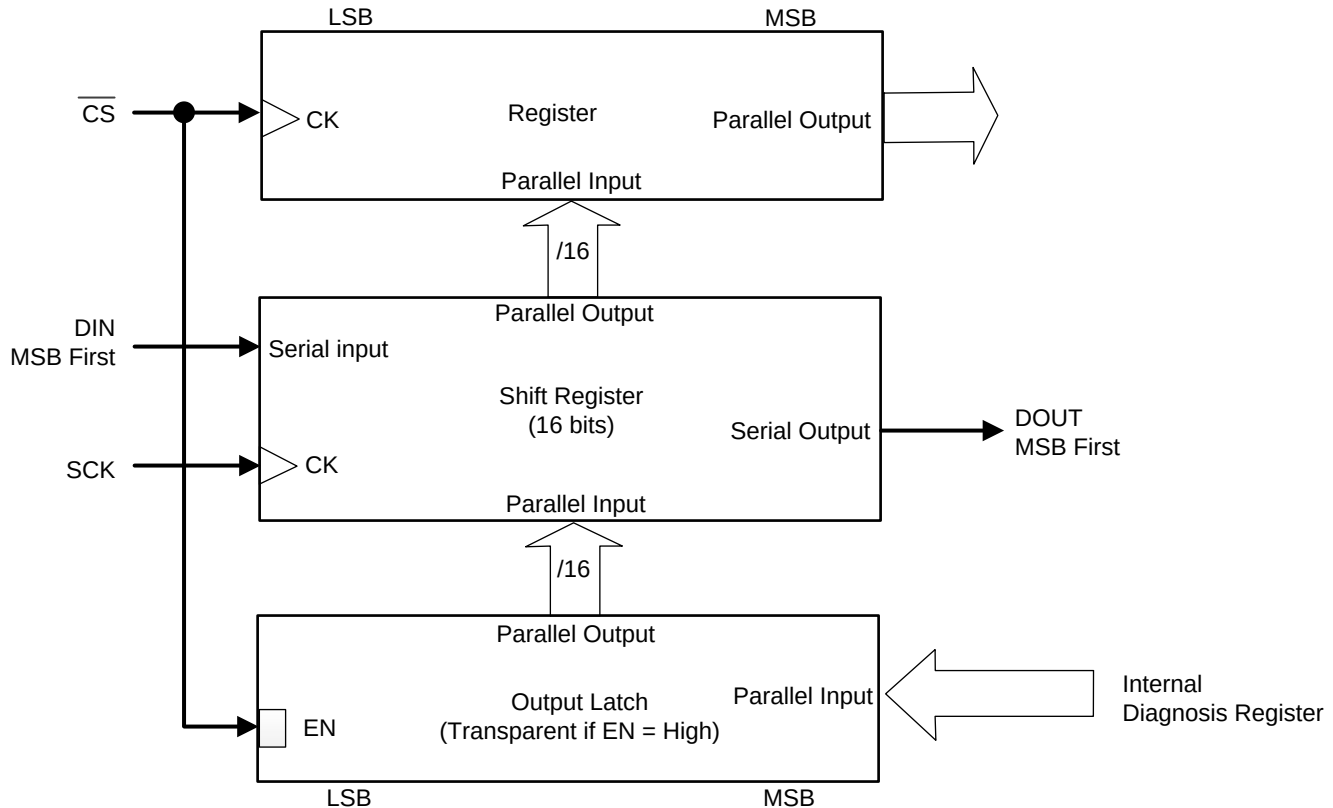


Figure 4. Block Diagram of SPI

- **$\overline{\text{CS}}$ – Chip Select**
 - This input signal is utilized to select this IC by CPU.
 - This input signal is normally high and the communication is possible only when it is forced low.
 - When this input signal falls, the communication between this IC and the CPU starts.
 - Transmitted data is latched and the DOUT pin comes out of high impedance.
 - When this input signal rises, the communication stops.
 - The DOUT pin goes into high impedance. Then, the internal input register updates with the received bits (only if the clock pulse numbers are right and the key bit of the DIN signals is correct).
 - The next falling edge starts another communication.
 - There is a minimum waiting time between two communications (T_{wait}).
 - The pin has an internal pullup.
- **SCK – Synchronization Serial Clock**
 - This input signal is utilized to synchronize the communication by CPU.
 - It is normally high and the correct clock pulse number is 16.
 - At each falling edge, the CPU writes a new bit on the DIN input and this IC writes a new bit on the DOUT pin. At each rising edge, this IC reads the new bit on the DIN pin and the CPU reads the new bit on the DOUT pin.
 - The maximum clock frequency is 4 MHz.
 - The pin has an internal pullup.

- **DIN – Serial Input Data**
 - This input signal is used to receive 16-bit data.
 - The bits are received in order from the MSB (first) to the LSB (last).
 - The pin has an internal pullup.
- **DOUT – Serial Output Data**
 - This output signal is used to transmit 16-bit data.
 - It is a 3-state output and it is in high impedance mode when $\overline{\text{CS}}$ is high.
 - The serial data bits are transmitted in order from the MSB (first) to the LSB (last).

SPI ELECTRICAL CHARACTERISTICS

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER ⁽¹⁾		CONDITIONS	MIN	TYP	MAX	UNITS
SPI						
F_{op}	Operating frequency	Refer to Figure 6	DC	–	4	MHz
T_{lead}	Enable lead time		100	–	–	ns
T_{wait}	Wait time between two successive communications		5	–	–	μs
T_{lag}	Enable lag time		100	–	–	ns
T_{pw}	SCLK pulse width		100	–	–	ns
T_{su}	Data setup time		80	–	–	ns
T_{h}	Data hold time		80	–	–	ns
T_{dis}	Disable time		–	–	80	ns
T_{del}	Data delay time (SCK to DOUT)	$C_L = 50\text{ pF}$, Refer to Figure 6	–	–	80	ns

(1) Specified by design

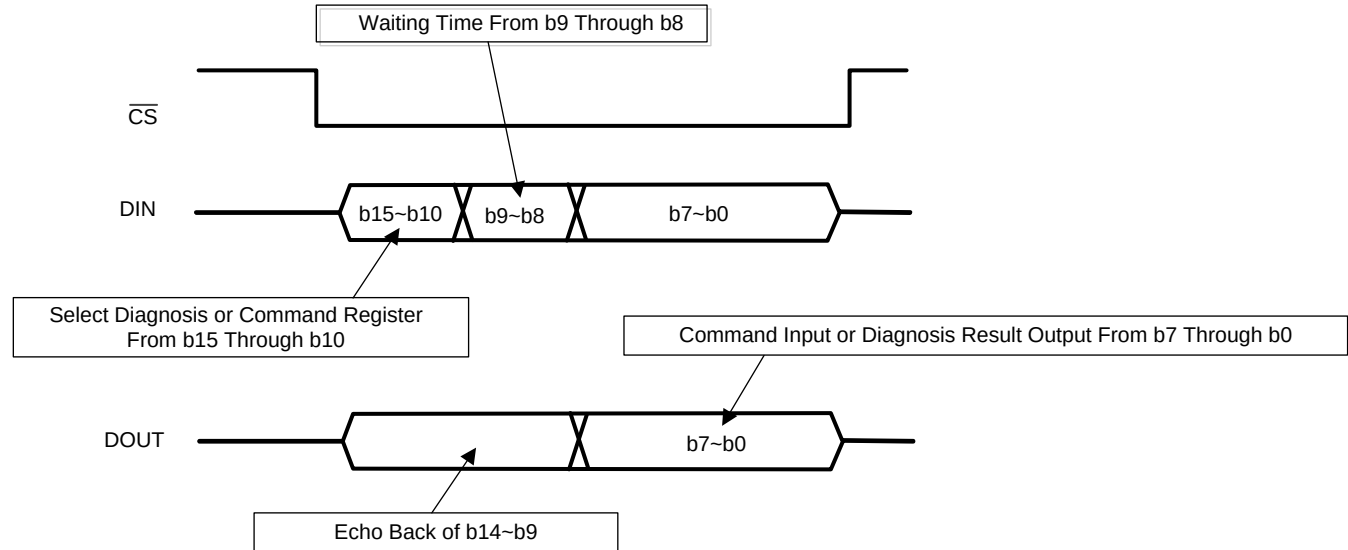


Figure 5. SPI Bit Sequence

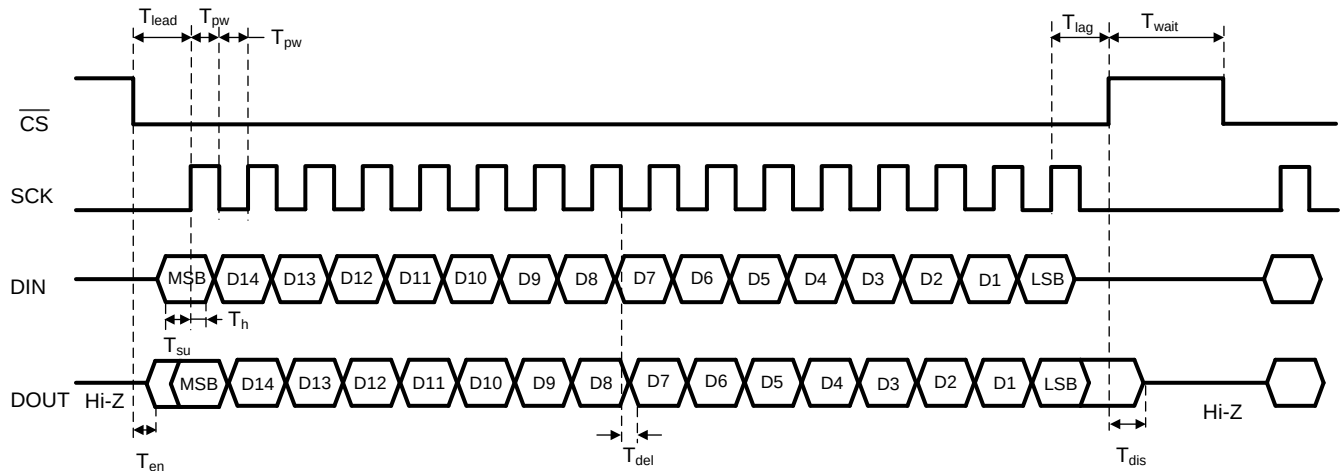


Figure 6. SPI AC Timing Definition

Table 1. SPI Bit Map (DIN)

ITEM	B15	B14	B13	B12	B11	B10	B9	B8	B7	B6	B5	B4	B3	B2	B1	B0
COMMAND1	0	0	0	0	0	1	–	–	SHM	SRT	–	–	–	–	–	–
COMMAND2	0	0	0	0	1	0	–	–	AG1	AG0	–	–	–	–	–	–
COMMAND3	0	0	0	0	1	1	–	–	–	–	–	–	–	–	–	–
DIAG_READ1	0	0	1	0	0	0	–	–	–	–	–	–	–	–	–	–
DIAG_READ2	0	1	0	0	0	0	–	–	–	–	–	–	–	–	–	–
DIAG_READ3	0	1	1	0	0	0	–	–	–	–	–	–	–	–	–	–

In [Table 1](#), the B15–B10 are the control bits, so the each command depends on them (listed below).

1. **B15-B10 = 0 0 0 0 0 1**

These are the commands:

1) Phase AMP Sampling Hold Mode (B7 bit)

0: OFF (through) (INITIAL VALUE)

1: ON (use sample hold mode)

2) Phase AMP Short Mode [Short_Mode] (B6 bit)

0: OFF (no calibration) (INITIAL VALUE)

1: ON (use calibration mode)

2. **B15-B10 = 0 0 0 0 1 0**

These are the commands:

1) Phase AMP Gain (B7 bit and B6 bit)

B7:0 B6:0; Gain x1 (INITIAL VALUE)

B7:0 B6:1; Gain x2

B7:1 B6:0; Gain x3

B7:1 B6:1; Gain x4

3. **B15-B10 = 0 0 0 0 1 1**

Not used

4. **B15-B10 = 0 0 1 0 0 0**

This command is to read the diagnosis of the current regulator, SPI communication, overvoltage detection, and input diagnosis.

5. **B15-B10 = 0 1 0 0 0 0**

This command is to read the diagnosis of SPI communication.

6. **B15-B10 = 0 1 1 0 0 0**

Not used

7. B15-B10 = Other command

This command sets the SPI-NG (DOUT, B7) bit.

Table 2. SPI Bit Map (DOUT)

ITEM	B15	B14	B13	B12	B11	B10	B9	B8	B7	B6	B5	B4	B3	B2	B1	B0
ON/OFF COMMAND ECHO BACK	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0
	0	0	0	0	0	1	0	0	–	–	–	–	–	–	–	–
	0	0	0	0	0	1	1	0	–	–	–	–	–	–	–	–
DIAG_READ1	0	0	0	1	0	0	0	0	VCC	Rsvd	CCD	VCO	VDO	CPLV	TD	EEP
DIAG_READ2	0	0	1	0	0	0	0	0	SPI	–	–	–	–	–	–	–
DIAG_READ3	0	0	1	1	0	0	0	0	–	–	–	–	–	–	–	–

1. B14-B9 = 0 0 1 0 0 0

This flag is cleared after the register is read by the CPU.

1) V_{CC} Current Detection (B7)

0: NORMAL

1: Fail (Short to GND or open)

2) Overcurrent Detection (B6)

0: NORMAL

1: Fail (Overcurrent)

4) V_{CC} Overvoltage Detection (B4)

0: NORMAL

1: Fail (V_{CC} overvoltage)

5) V_{DD} Overvoltage Detection (B3)

0: NORMAL

1: Fail (V_{DD} overvoltage)

6) CPV Low Voltage Detection (B2)

0: NORMAL

1: Fail (CPV low voltage)

7) Thermal Detection (B1)

0: NORMAL

1: Fail (Overtemperature)

8) EEPROM* Data Consistency Check (B0)

0: NORMAL

1: Fail (EEPROM DATA CRC error)

*ASIC calibration EEPROM

NOTE

Just after power-on of the IC, some of the bits listed above may be set depending on the apply sequence of VB. It is recommended to issue a DIAG_READ1 to clear these bits prior to all S/W sequences.

2. B14-B9 = 0 1 0 0 0 0

This flag is cleared after the register is read by the CPU.

1) SPI-NG (B7)

0: NORMAL

1: Fail (SPI read and write command is wrong)

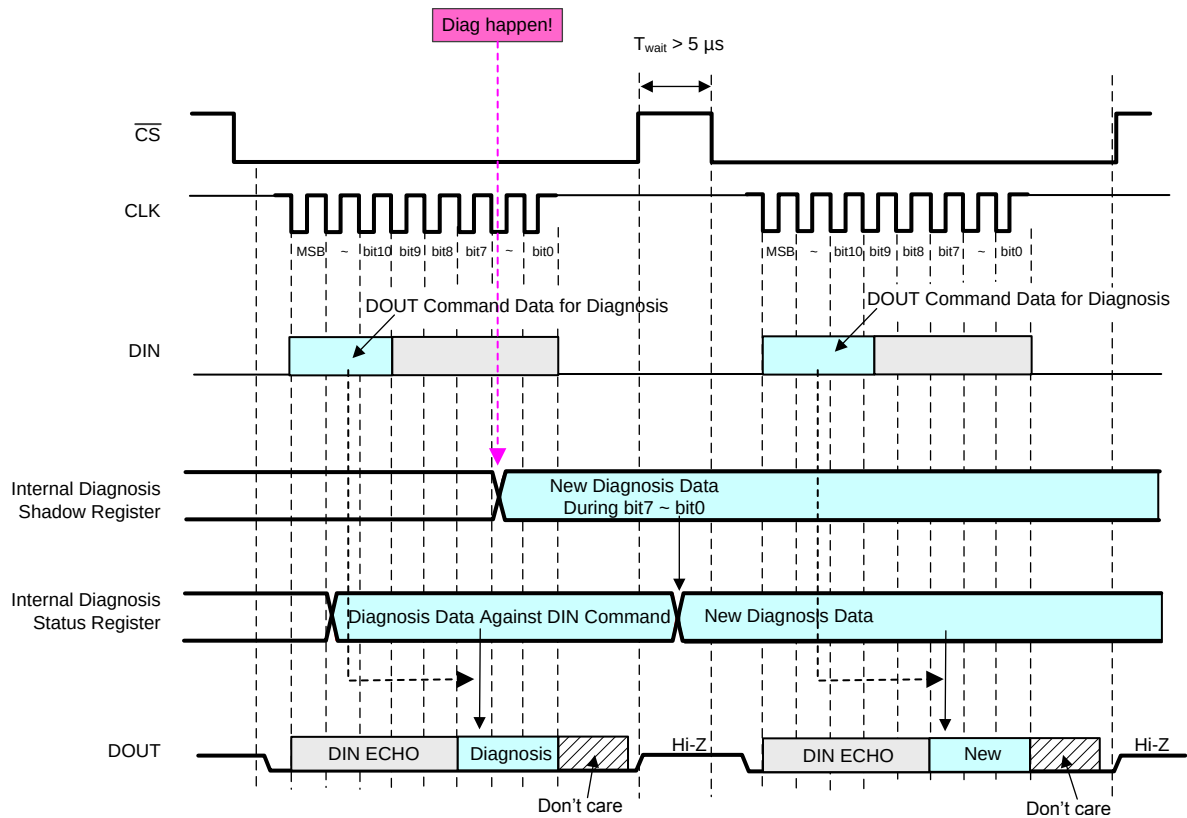


Figure 7. DIAG_READ

Internal Diagnosis Register (Status Register and Shadow Register)

If the diagnosis happens during the SPI communication, the function follows this protocol:

The diagnosis information is stored in the shadow register when the diagnosis happens.

After the output of the previous information a new diagnosis is sent from the shadow to the status register, and both registers are output through the DOUT pin.

In this case, a FAULT signal continues to be output until a new diagnosis is read by the CPU.

All diagnosis bits read by the DIAG_READ1 command happen before the $\overline{CS}$ falling edge. So, all the diagnosis events that happen right after the $\overline{CS}$ falling edge are not read by the current DIAG_READ1 command, instead they are read by the next DIAG_READ1 command.

CHARGE PUMP

Description

The charge pump block generates the supply for high-side and low-side pre-drivers to maintain the gate voltage on the external FETs. External storage cap (CCP) and bucket caps (C1, C2) are used to support pre-driver slope and switching frequency requirements. R1 and R2 can reduce switching current if required. The charge pump has a voltage supervisor for over and undervoltage, and a selectable stop condition for pre-drivers.

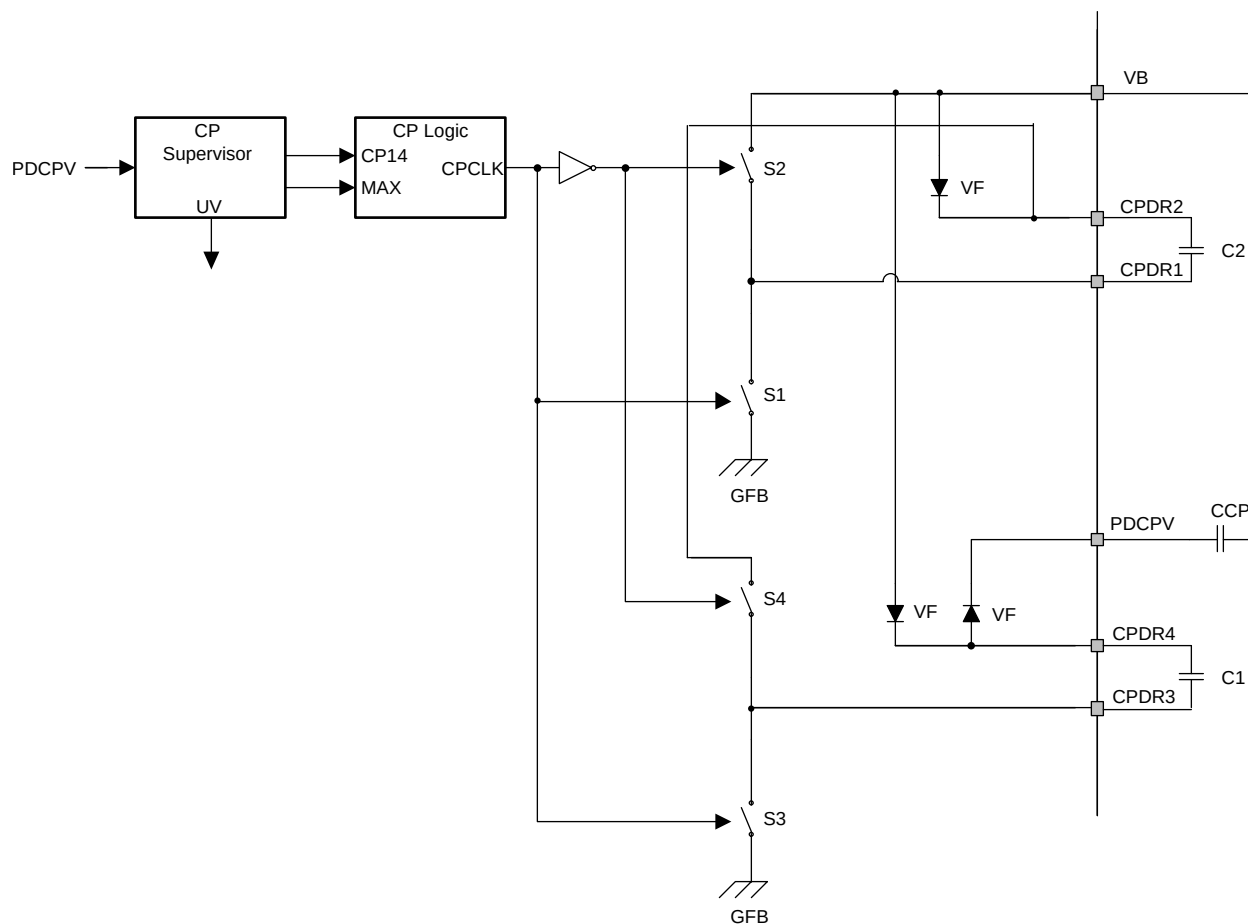


Figure 8. Charge Pump Block Diagram

PRODUCT PREVIEW

CHARGE PUMP ELECTRICAL CHARACTERISTICS⁽¹⁾VB = 12 V, T_A = -40°C to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
CHARGE PUMP						
V _{chv1_0}	Output voltage	VB = 5.3 V, I _{load} = 0 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 7	VB + 8	VB + 9	V
V _{chv1_1}		VB = 5.3 V, I _{load} = 5 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 6	VB + 7	VB + 8	V
V _{chv1_2}		VB = 5.3 V, I _{load} = 8 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 5	VB + 6	VB + 7	V
V _{chv2_0}		VB = 12 V, I _{load} = 0 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 13	VB + 14	VB + 15	V
V _{chv2_1}		VB = 12 V, I _{load} = 11 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 13	VB + 14	VB + 15	V
V _{chv2_2}		VB = 12 V, I _{load} = 18 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 12.5	VB + 13.5	VB + 15	V
V _{chv3_0}		VB = 18 V, I _{load} = 0 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 13	VB + 14	VB + 15	V
V _{chv3_1}		VB = 18 V, I _{load} = 13 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 13	VB + 14	VB + 15	V
V _{chv3_2}		VB = 18 V, I _{load} = 22 mA, C1 = C2 = 47 nF, CCP = 2.2 μF	VB + 13	VB + 14	VB + 15	V
V _{chvmax}	Maximum voltage		35	37.5	40	V
V _{chvUV}	Undervoltage detection threshold		VB + 4	VB + 4.5	VB + 5	V
T _{chv} ⁽²⁾	Rise time	VB = 5.3 V, C1 = C2 = 47 nF, CCP = 2.2 μF, V _{chvUV} released		1	2	ms
R _{on}	On resistance S1~S4			8		Ω

(1) No variation of the external components

(2) Specified by design

PRE-DRIVER

Description

The pre-driver block provides three high-side pre-drivers and three low-side pre-drivers to drive external N-channel MOSFETs. The turn on side of the high-side pre-drivers supply the large N-channel transistor current to quickly charge and PMOS support output voltage up to PDCPV. The turn off side supplies the large N-channel transistor current to quickly discharge, while the low-side pre-drivers supply the large N-channel transistor current for charge and discharge. The output voltage of the low-side pre-driver is controlled by VB and it has VGS protection to make less than 18 V. The pre-driver has a stop condition in some fault conditions (\$16 Error Detection).

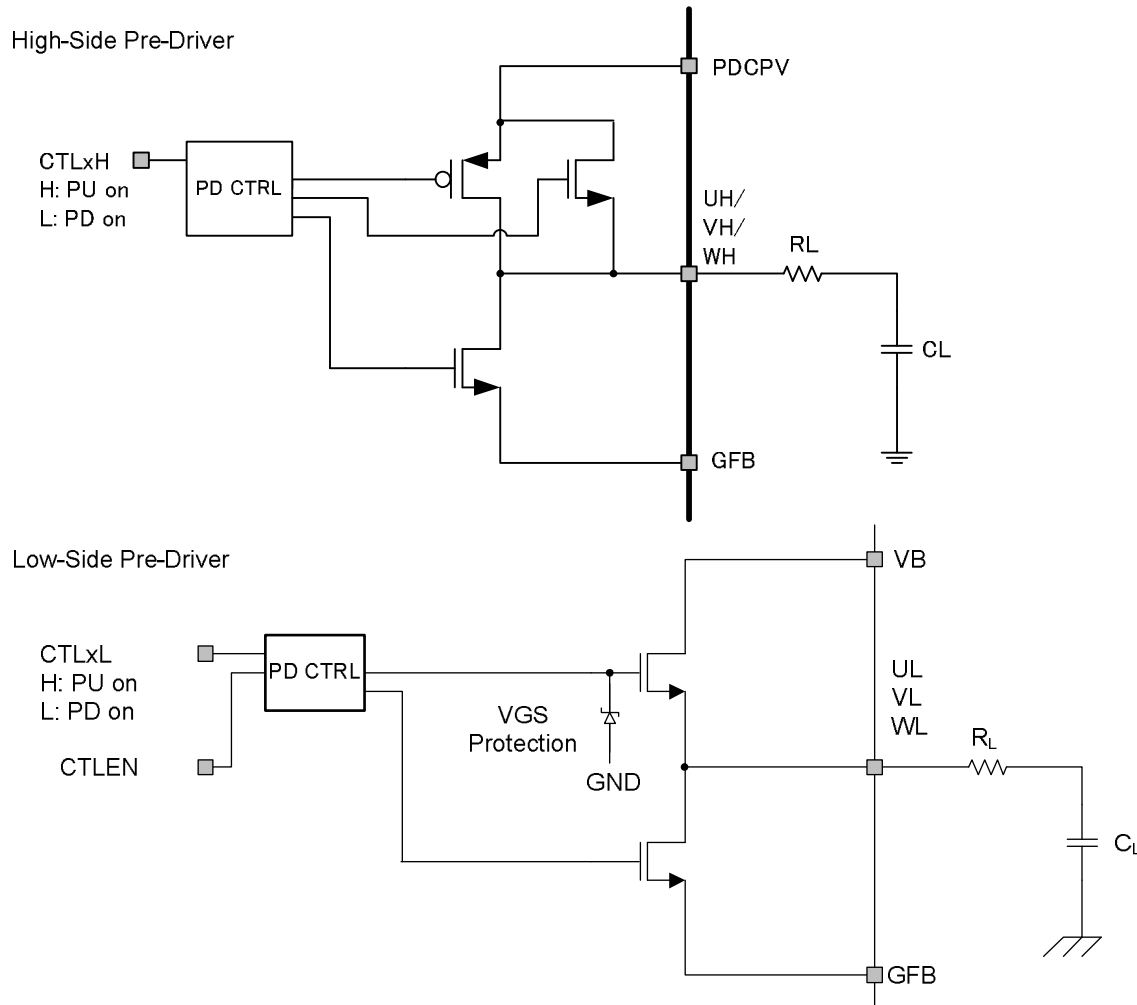


Figure 9. Pre-driver Block Diagram

PRODUCT PREVIEW

PRE-DRIVER ELECTRICAL CHARACTERISTICS

VB = 12 V, TA = –40°C to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
HIGH SIDE PRE-DRIVER						
VOH_H	Output voltage high	Isink = 10 mA, U(V/W)H – GFB	Vchv – 2.7	Vchv – 1.35		V
VOL_H	Output voltage low	Isource = 10 mA, U(V/W)H – GFB		60	120	mV
RONH_HP	ON resistance pull up (Pch)	U(V/W)H = PDCPV - 1 V		135	270	Ω
RONH_HN	ON resistance pull up (Nch)	U(V/W)H = PDCPV - 2.5 V		8	16	Ω
RONL_H	ON resistance pull down			6	12	Ω
Ton_h ⁽¹⁾	Turn-on time	VB = 5.3 ~ 18 V, CL = 11 nF, RL = 0 Ω from 20% to 80%	100	300	500	ns
Toff_h ⁽¹⁾	Turn-off time	VB = 5.3 ~ 18 V, CL = 11 nF, RL = 0 Ω from 80% to 20%	100	300	500	ns
Th_ondly ⁽¹⁾	Output delay time	VB = 5.3 ~ 18 V, CL = 11 nF, RL = 0 Ω to 20%, see Figure 10	100	200	400	ns
Th-offdly ⁽¹⁾	Output delay time	VB = 5.3 ~ 18 V, CL = 11 nF, RL = 0 Ω to 80%, see Figure 10	100	200	400	ns
LOW SIDE PRE-DRIVER						
VOH_L	Output voltage high	Isink = 10 mA, U(V/W)L – GFB	VB – 0.14	VB-0.07		V
VOL_L	Output voltage low	Isource = 10 mA, U(V/W)L – GFB		70	140	mV
RONH_L	ON resistance pull up			7	14	Ω
RONL_L	ON resistance pull down			7	14	Ω
Ton_l ⁽¹⁾	Turn-on time	VB = 5.3 ~ 18 V, CL = 22 nF, RL = 0 Ω from 20% to 80%	100	300	800	ns
Toff_l ⁽¹⁾	Turn-off time	VB = 5.3 ~ 18 V, CL = 22 nF, RL = 0 Ω from 80% to 20%	100	300	800	ns
Tl_ondly ⁽¹⁾	Output delay time	VB = 5.3 ~ 18 V, CL = 22 nF, RL = 0 Ω to 20%, see Figure 10	100	200	400	ns
Tl-offdly ⁽¹⁾	Output delay time	VB = 5.3 ~ 18 V, CL = 22 nF, RL = 0 Ω to 80%, see Figure 10	100	200	400	ns
VCLAMP	VGS protection voltage		16	18	20	V
Tdiff1 ⁽¹⁾	Differential time 1	VB = 5.3 ~ 18 V (Th-on)–(Tl-off), see Figure 10	–300		300	ns
Tdiff2 ⁽¹⁾	Differential time 2	VB = 5.3 ~ 18 V (Tl-on)–(Th-off), see Figure 10	–300		300	ns

(1) Specified by design

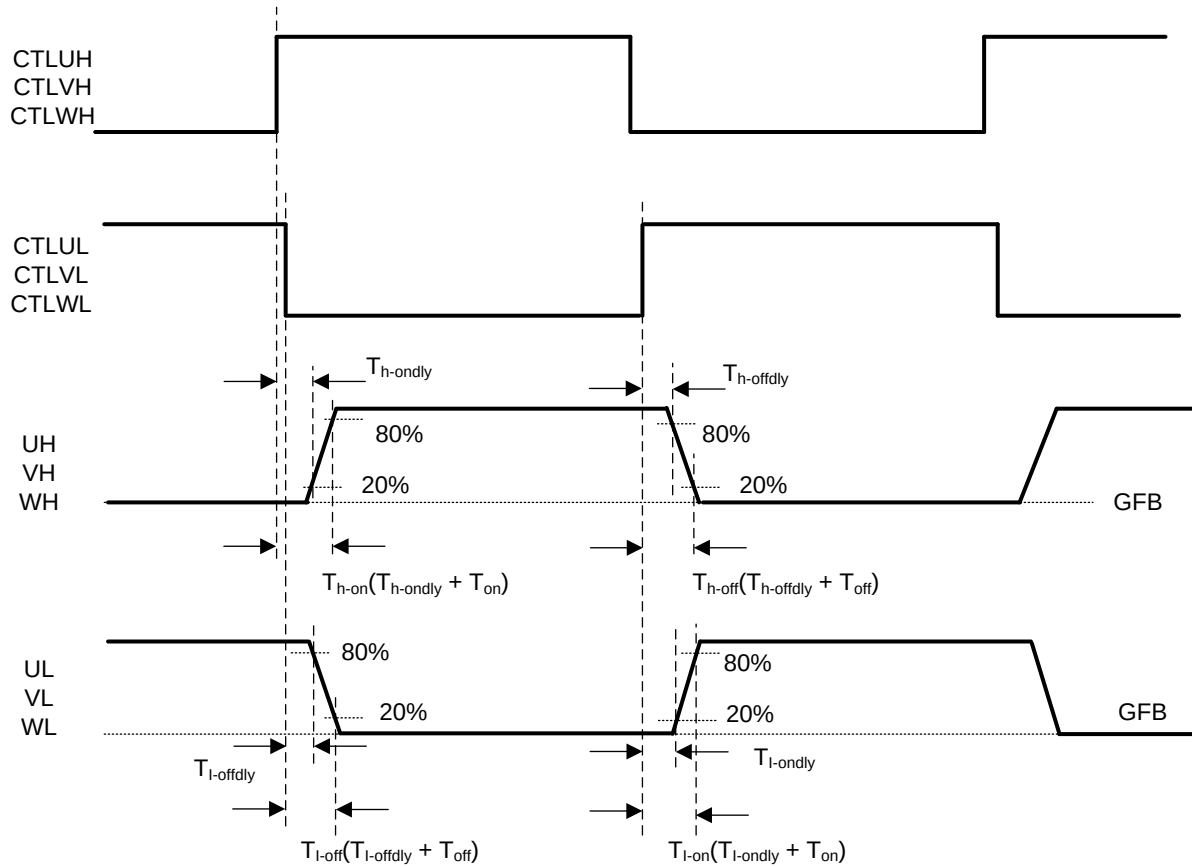


Figure 10. Delay Time from Input to Output

PRODUCT PREVIEW

PHASE COMPARATOR

Description

A 3-channel comparator module monitors the external FET by detecting voltage across the drain-source for high-side and low-side FETs. PHTM is the threshold level of comparators usable for sensorless communication. Figure 11 shows an example of the threshold level. There is no detection when CTLEN = Low.

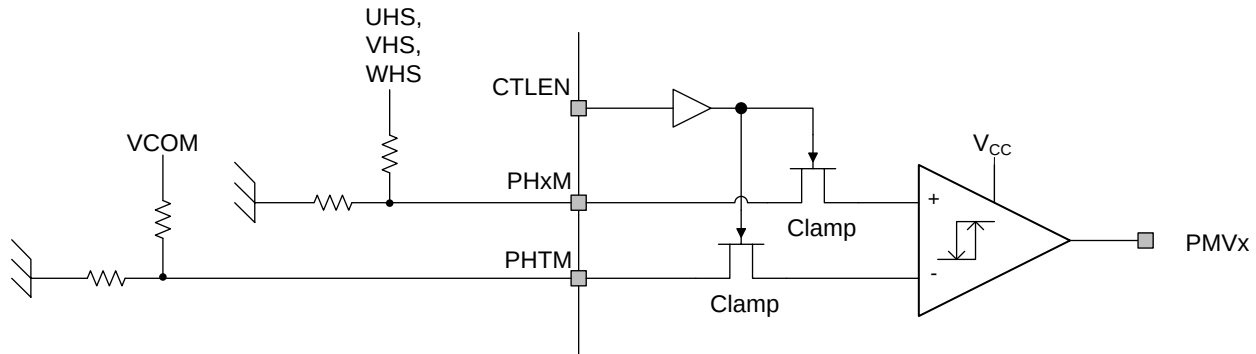


Figure 11. Phase Comparator Block Diagram

PHASE COMPARATORS ELECTRICAL CHARACTERISTICS

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
PHASE COMPARATOR						
V_{iofs}	Input offset voltage		-15	-	15	mV
V_{inp}	Input voltage range (PHTM)	$V_B = 5.3 \sim 18\text{ V}$	1.325	-	4.5	V
V_{inm}	Input voltage range (PHxM)		-1	-	V_B	V
V_{ihys}	Input hysteresis voltage		100	200	400	mV
V_{OH}	Output high voltage	$I_{sink} = 2.5\text{ mA}$	$0.9 \times V_{CC}$	-	-	V
V_{OL}	Output low voltage	$I_{source} = 2.5\text{ mA}$	-	-	$0.1 \times V_{CC}$	V
$T_{res_tr}^{(1)}$	Response time (rising)	$C_L = 100\text{ pF}$	-	0.2	0.5	μs
$T_{res_tf}^{(1)}$	Response time (falling)	$C_L = 100\text{ pF}$	-	0.4	1	μs

(1) Specified by design

MOTOR CURRENT SENSE

Description

The operational amplifier is operating with an external resistor network for higher flexibility to adjust the current measurement to application requirements. The first stage amplifier is operating with the external resistor and the output voltage up to V_B at ALFB. The gain of the amplifier is adjustable by external resistors from $\times 10$ to $\times 30$. The second stage amplifier is a buffer to MCU at ALV. Current sense has a comparator for motor overcurrent (OVAD). ADTH is the overcurrent threshold level and sets the value by the external resistor as well. [Figure 13](#) shows the curve of the detection level. ALFB is divided by 2, compare this value with ADTH. In the recommended application, zero-point adjustment is required as a large error offset in the initial condition.

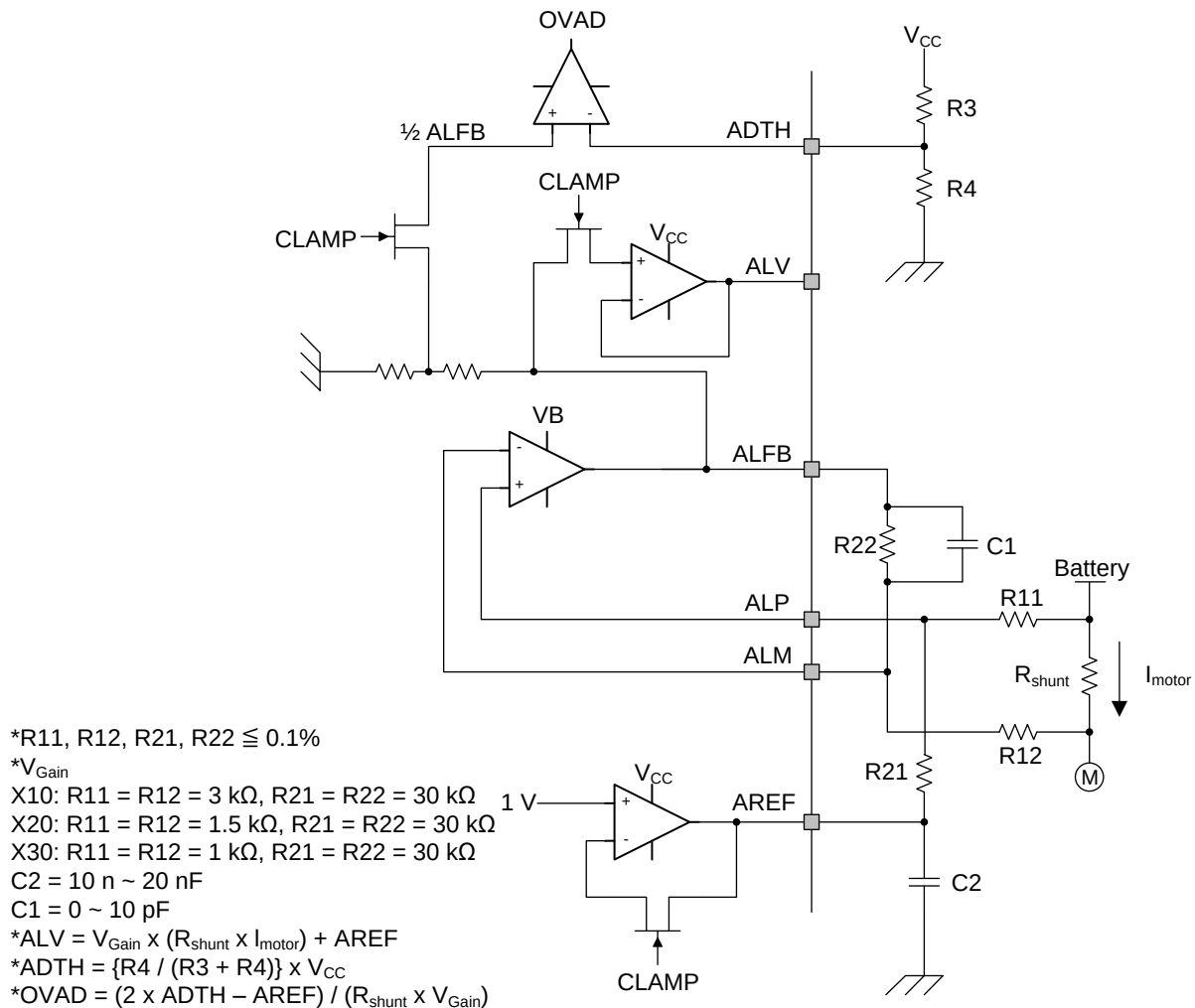


Figure 12. Motor Current Sense Block Diagram

MOTOR CURRENT SENSE ELECTRICAL CHARACTERISTICS⁽¹⁾

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
MOTOR CURRENT⁽²⁾ SENSE						
V _{Ofs}	Input offset voltage		-5		5	mV
V _{O_0}	Output voltage (ALV)	V _B = 5.3 ~ 18 V, I _{motor} = 0 A		1		V

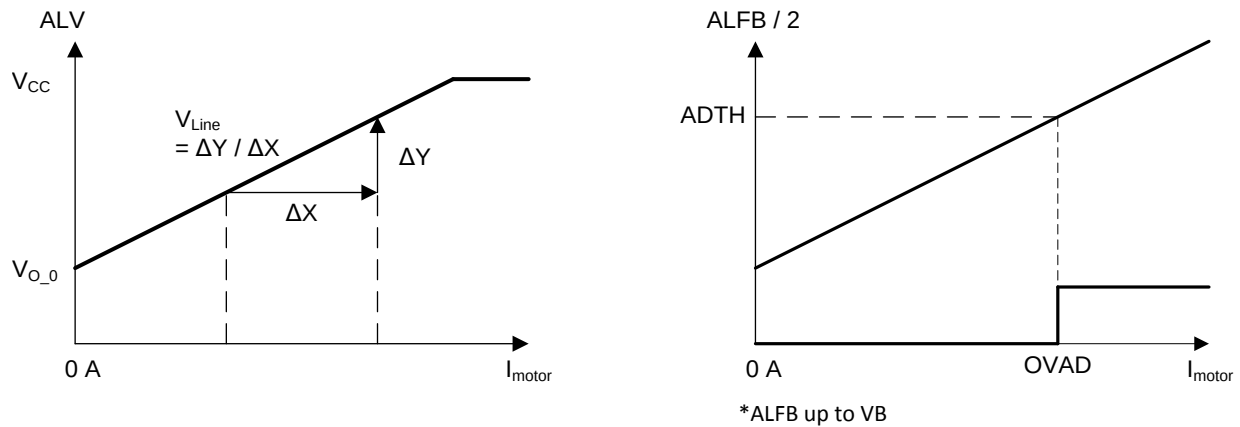
(1) No variation of the external components

- (1) No variation of the external components
- (2) Motor current is converted to voltage in test

MOTOR CURRENT SENSE ELECTRICAL CHARACTERISTICS⁽¹⁾ (continued)VB = 12 V, T_A = –40°C to 125°C (unless otherwise specified)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
V _{Line} Linearity (ALV)	VB = 5.3 ~ 18 V, R _{shunt} = 1 mΩ, R11 = R12 = 1 kΩ, R21 = R22 = 30 kΩ	–2%	30	2%	mV/A
V _{Gain} Gain		10		30	
T _{set_TR1} Settling time (Rise) ALV ±1%	VB = 5.3 ~ 18 V, R _{shunt} = 1 mΩ, C1 = 4.7 pF, C _L = 100 pF, R11 = R12 = 1 kΩ, R21 = R22 = 30 kΩ, I _{motor} = 0 → 30 A, (ALV : 1 → 1.9 V)	–	1	2.5	μs
T _{set_TR2} Settling time (Rise) ALV ±1%	VB = 5.3 ~ 18 V, R _{shunt} = 1 mΩ, C1 = 4.7 pF, C _L = 100 pF, R11 = R12 = 1 kΩ, R21 = R22 = 30 kΩ, I _{motor} = 0 → 100 A, (ALV : 1 → 4 V)	–	1	2.5	μs
T _{set_TF1} Settling time (Fall) ALV ±1%	VB = 5.3 ~ 18 V, R _{shunt} = 1 mΩ, C1 = 4.7 pF, C _L = 100 pF, R11 = R12 = 1 kΩ, R21 = R22 = 30 kΩ, I _{motor} = 30 → 0 A, (ALV : 1.9 → 1 V)	–	1	2.5	μs
T _{set_TF2} Settling time (Fall) ALV ±1%	VB = 5.3 ~ 18 V, R _{shunt} = 1 mΩ, C1 = 4.7 pF, C _L = 100 pF, R11 = R12 = 1 kΩ, R21 = R22 = 30 kΩ, I _{motor} = 100 → 0 A, (ALV : 4 → 1 V)	–	1	2.5	μs
OVAD Overcurrent threshold	150-A detection, R _{shunt} = 1 mΩ, R11 = R12 = 1 kΩ, R21 = R22 = 30 kΩ, R3 = 8.2 kΩ, R4 = 10 kΩ	–10%	150	10%	A
TDEL_OVAD ⁽³⁾ Propagation delay (Rise or fall)		–	–	1.5	μs

(3) Specified by design

**Figure 13. Motor Current Sense and Overcurrent**

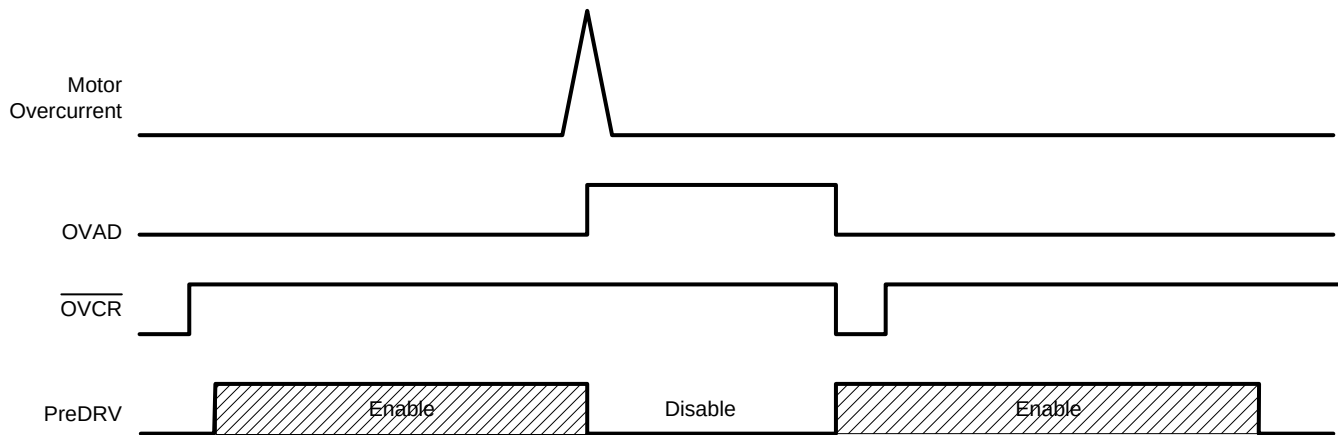


Figure 14. Motor Overcurrent Event

Table 3. Motor Overcurrent Truth Table

$\overline{\text{RES}}$	$\overline{\text{OVCR}}$	MOTOR OVERCURRENT	OVAD	PRE-DRIVER ENABLE OR DISABLE
0	–	–	0 (Clear)	Disable ⁽¹⁾
1	0	–	0 (Clear) ^{(2) (3)}	Enable
	1	0	Keep	Enable
		1	1 (Set)	Disable

- (1) The CTLEN goes to Hi-Z because the external CPU will not drive it when $\overline{\text{RES}} = 0$, then all the pre-drivers are turned off because CTLEN is internally pulled down.
- (2) The OVAD is not set, even if a motor overcurrent error is generated during $\overline{\text{OVCR}} = 0$.
- (3) The OVAD is cleared if $\overline{\text{OVCR}} = 0$ even when the motor overcurrent error is generated.

PHASE AMPLIFIER (Sample and Hold Mode and Through Mode)

Description

The 3-channel amplifier module monitors the drain-source for high-side and low-side FETs. Two modes (selected by the SPI) are provided: sample and hold mode, and through mode. Sample and hold is controlled by PSSx at the external pins and PSCx connects the charging capacitor. Through mode is real-time detection and the amplifier has x1–x4 gain control.

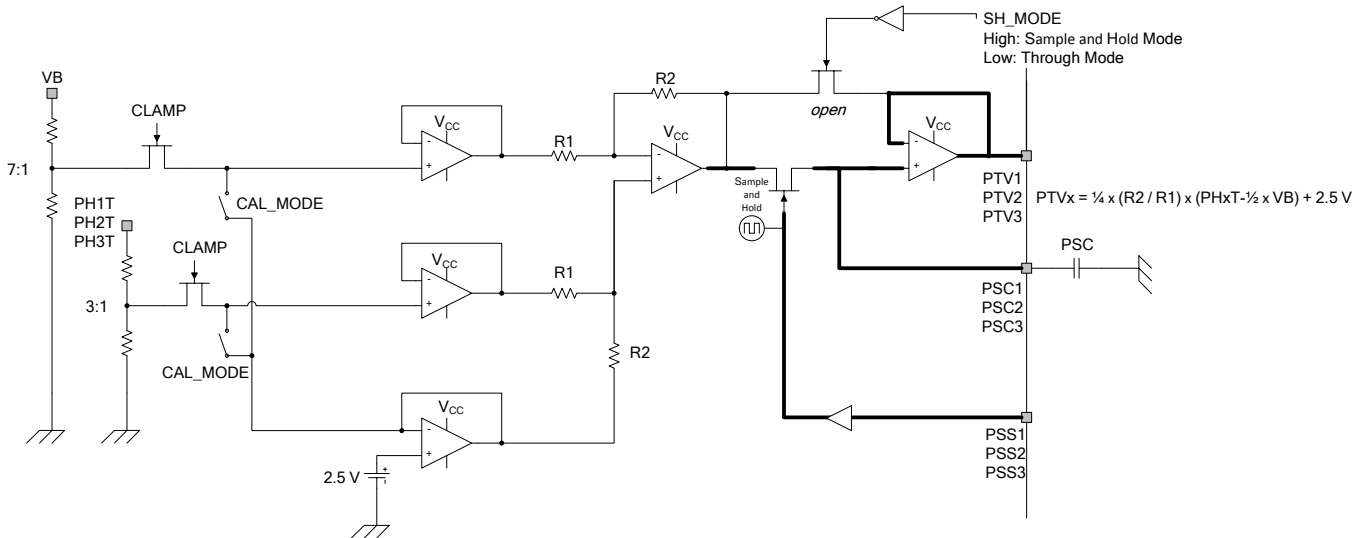


Figure 15. Sample and Hold Mode Block Diagram

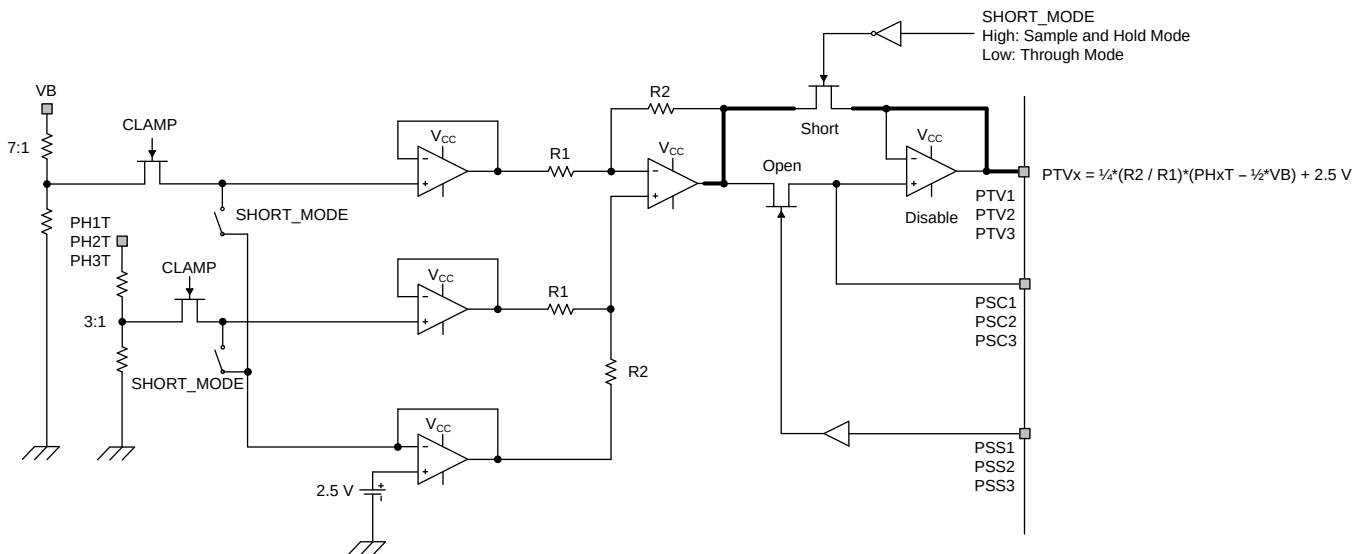


Figure 16. Through Mode Block Diagram

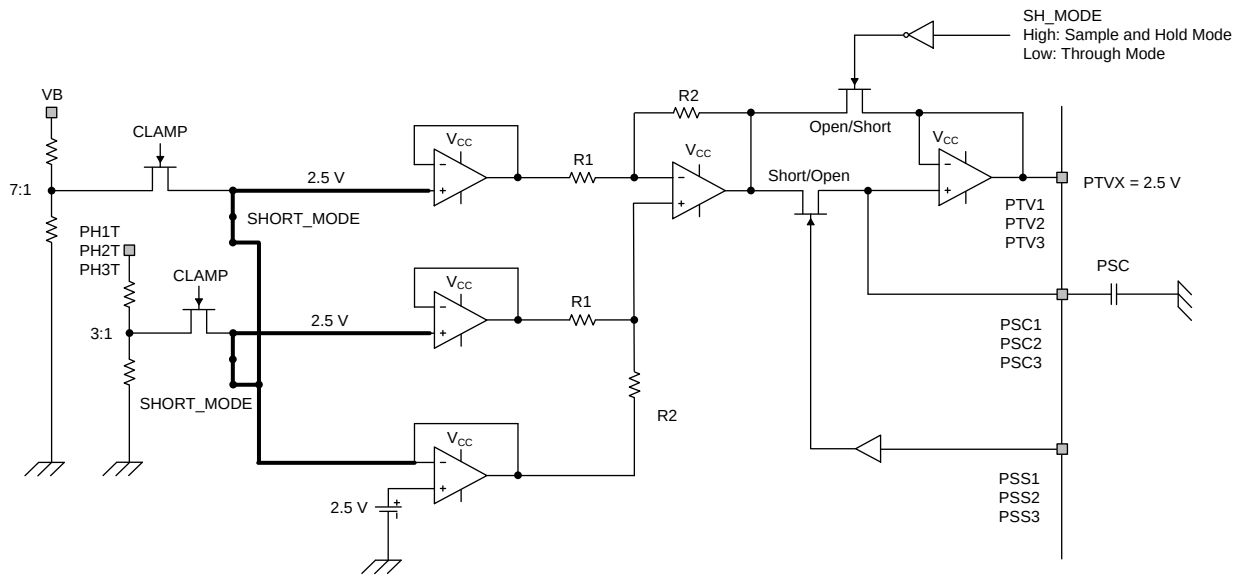


Figure 17. Short Mode (Optional) Block Diagram

PRODUCT PREVIEW

PHASE AMPLIFIER ELECTRICAL CHARACTERISTICS⁽¹⁾

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
PHASE AMPLIFIER						
V_{ofs_SH}	Output offset voltage, sample and hold mode	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1	-50	–	50	mV
V_{ofs_TH}	Output offset voltage, through mode	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1	-50	–	50	mV
V_{in_cm}	Common mode input range	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1–4	1.5		$V_B - 1.5$	V
V_{out_max}	Maximum output voltage	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1–4	4.5	–	–	V
V_{out_min}	Minimum output voltage	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1–4	–	–	0.5	V
$V_{gain}^{(2)}$	Gain		–	1 2 3 4	–	
V_{out_SH0}	Output voltage, sample and hold mode	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1–4, PHxT = $V_B / 2$	–	2.5	–	V
V_{out_TH0}	Output voltage, through mode	$V_B = 5.3\text{--}18\text{ V}$, Gain = 1–4 PHxT = $V_B / 2$	–	2.5	–	V
V_{out_SH1}	Output voltage, sample and hold mode	$V_B = 12\text{ V}$, Gain = 1, PHxT = 1.5 V	–	1.375	–	V
V_{out_TH1}	Output voltage, through mode	$V_B = 12\text{ V}$, Gain = 1, PHxT = 1.5 V	–	1.375	–	V
V_{out_SH2}	Output voltage, sample and hold mode	$V_B = 12\text{ V}$, Gain = 1, PHxT = 10.5 V	–	3.625	–	V
V_{out_TH2}	Output voltage, through mode	$V_B = 12\text{ V}$, Gain = 1, PHxT = 10.5 V	–	3.625	–	V
STL_SHTR	Settling time (rise), sample and hold mode PTVx $\pm 1\%$	$V_B = 12\text{ V}$, Gain = 1, PSC = 470 pF, PTVx = 100 pF, PHxT = 1.5 V $\geq 10.5\text{ V}$, (PTVx = 1.375 V $\rightarrow$ 3.625 V), see Figure 20		1.5	3	μs
STL_THTR	Settling time (rise), through mode PTVx $\pm 1\%$	$V_B = 12\text{ V}$, Gain = 1, PTVx = 100 pF, PHxT = 1.5 V $\geq 10.5\text{ V}$, (PTVx = 1.375 V $\rightarrow$ 3.625 V), see Figure 21		1.5	3	μs
STL_SHTF	Settling time (fall), sample and hold mode PTVx $\pm 1\%$	$V_B = 12\text{ V}$, Gain = 1, PSC = 470 pF, PTVx = 100 pF, PHxT = 10.5 V $\geq 1.5\text{ V}$, (PTVx = 3.625 V $\rightarrow$ 1.375 V), see Figure 20		1.5	3	μs
STL_THTF	Settling time (fall), through mode PTVx $\pm 1\%$	$V_B = 12\text{ V}$, Gain = 1, PTVx = 100 pF, PHxT = 10.5 V $\geq 1.5\text{ V}$, (PTVx = 3.625 V $\rightarrow$ 1.375 V), see Figure 21		1.5	3	μs
SH Error Voltage	Falling voltage	$V_B = 5.3\text{--}18\text{ V}$, PSC = 470 pF, TH = 1 mS, see Figure 19		5	75	mV

(1) No variation of the external components.

(2) V_{gain} is an SPI setting

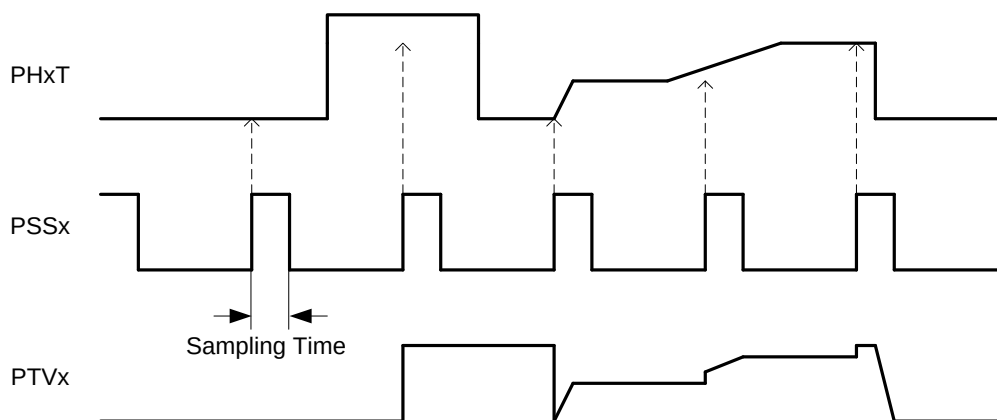


Figure 18. Sampling Timing Chart

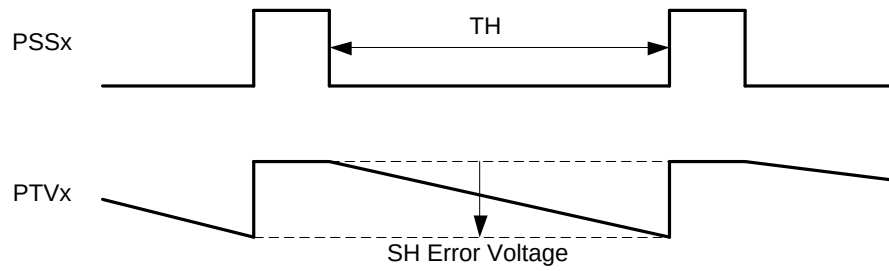


Figure 19. Holding Timing Chart

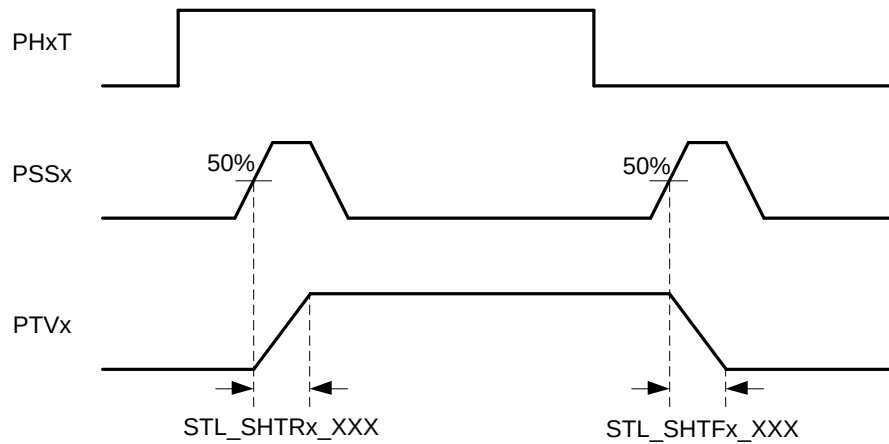


Figure 20. Settling Time Timing Chart (Sample and Hold Mode)

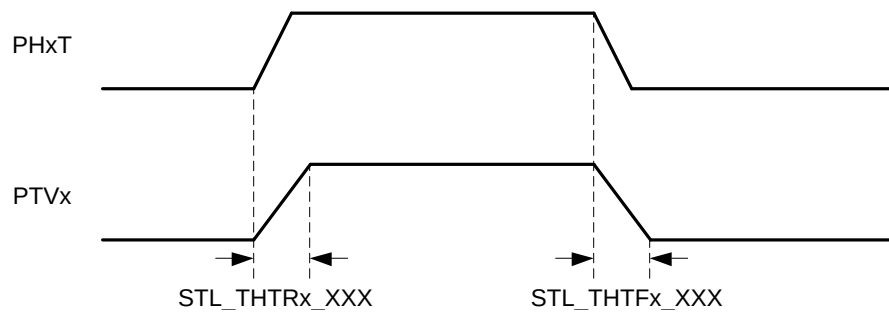


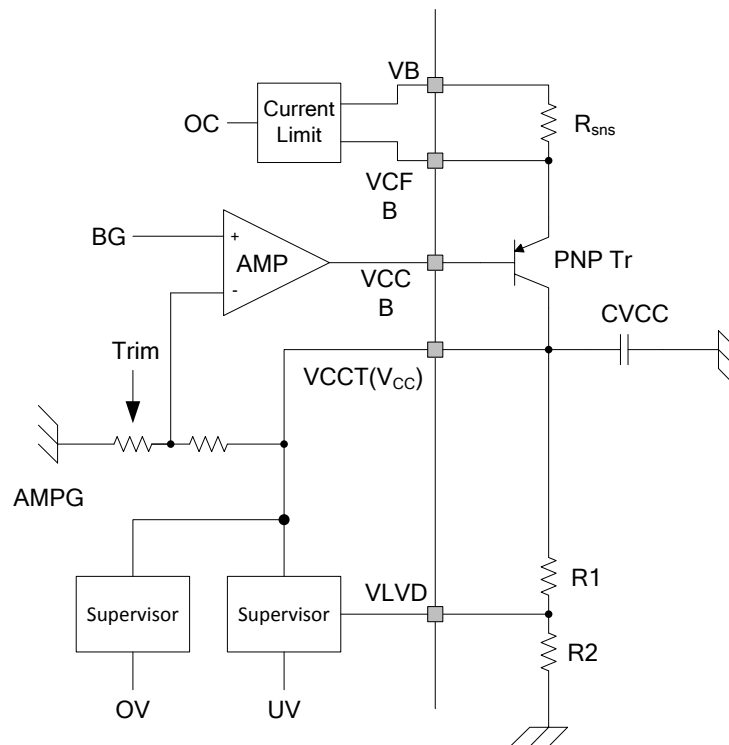
Figure 21. Settling Time Timing Chart (Through Mode)

REGULATORS

Description

The regulator block offers a 5-V LDO and a 3.3-V LDO. The V_{CC} LDO regulates V_B down to 5 V with an external PNP controlled by the regulator block. The 5-V LDO is supplied to the MCU and other components. The 5-V LDO is protected against a short to GND fault, and the external resistors R_1 and R_2 set the undervoltage. The V_{DD} regulator regulates V_B down to 3.3-V with an internal FET and a controller.

The regulators detect the overvoltage and undervoltage events of both supplies.



$$* R_{sns} = 0.2 \text{ V} / I_{CLVCC}$$

$$* V_{CCUV} = 2.325 \times \{(R_1 + R_2) / R_2\}$$

Figure 22. V_{CC} Block Diagram

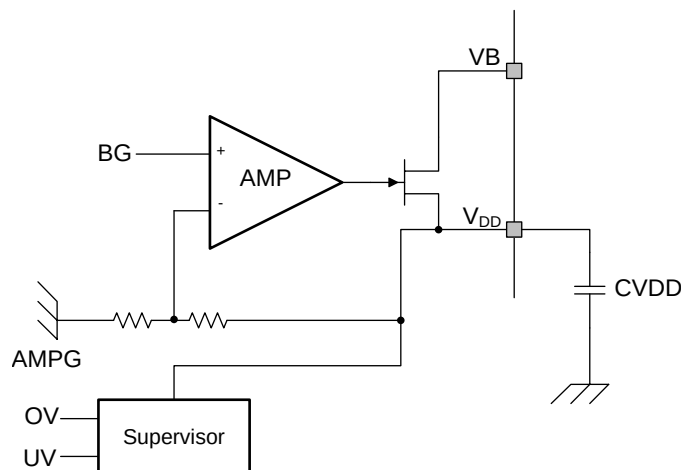


Figure 23. V_{DD} Block Diagram

V_{CC} AND V_{DD} ELECTRICAL CHARACTERISTICS⁽¹⁾

VB = 12 V, T_A = –40°C to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
V _{CC}						
V _{CC}	Output voltage	VB = 5.3–18 V, I _{load} = 5–150 mA	4.9	5	5.1	V
IBVCC	Base current		1.5			mA
hfePNP	DC current gain of external VCC		100			
VLRVCC	Load regulation	VB = 5.3–18 V, I _{load} = 5–150 mA	–50	–	50	mV
CVCC	Load capacitance		22		100	μF
RVCC	ESR of external capacitance				300	mΩ
VCCUV	Undervoltage detection threshold	R1 = 7.5 kΩ, R2 = 10 kΩ, VCCUV > 4 V	3.97	4.07	4.17	V
VCCUVHYS	Undervoltage detection threshold hysteresis			100		mV
VCCOV	Overvoltage detection threshold		6	6.5	7	V
ICLVCC	Current limit	R _{sns} = 0.51 Ω	300	400	550	mA
TVCC1	Rise time	V _{CC} > UVVCC, CVCC = 22 μF		0.3	0.5	ms
TVCC2	Rise time	V _{CC} > UVVCC, CVCC = 100 μF		1	1.5	ms
V _{DD}						
V _{DD}	Output voltage	VB = 5.3–18 V, I _{load} = 0–2 mA	3	3.3	3.6	V
CVDD	Load capacitance			1		μF
VDDUV	Undervoltage detection threshold		2.2	2.3	2.4	V
VDDOV	Overvoltage detection threshold		4.1	4.3	4.5	V
T _{vdd} ⁽²⁾	Rise time	V _{DD} > VDDUV, CVDD = 1 μF		75	150	μs

(1) No variation of the external components

(2) Specified by design

VB Monitor

Description

The block monitors VB overvoltage.

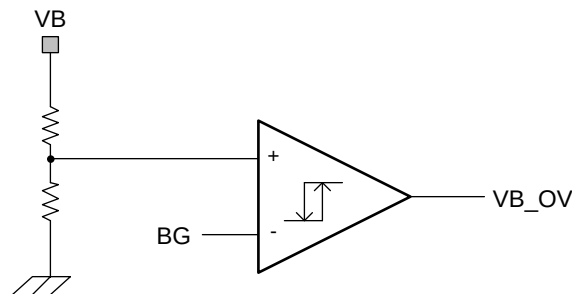


Figure 24. VB Monitor Block Diagram

VB MONITOR ELECTRICAL CHARACTERISTICS

VB = 12 V, T_A = –40°C to 125°C (unless otherwise specified)

PARAMETER	CONDITIONS	MIN	TYP	MAX	UNITS
VB MONITOR					
V _{stop}	Pre-driver stop VB voltage	26.5	27.5	28.5	V

THERMAL SHUTDOWN

Description

The device has temperature sensors that produce a pre-driver stop condition if the chip temperature exceeds 175°.

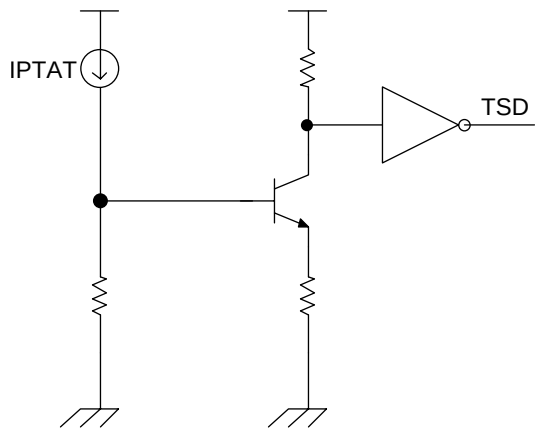


Figure 25. Thermal Shutdown Block Diagram

THERMAL SHUTDOWN ELECTRICAL CHARACTERISTICS

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
THERMAL SHUT DOWN						
TSD ⁽¹⁾	Thermal shut down threshold		155	175	195	°C

(1) Specified by design

OSCILLATOR

Description

Oscillator block generates two 10-MHZ clock signals. OSC1 is the main clock used for internal logic synchronization and timing control. OSC2 is the secondary clock which is used to monitor the status of OSC1.

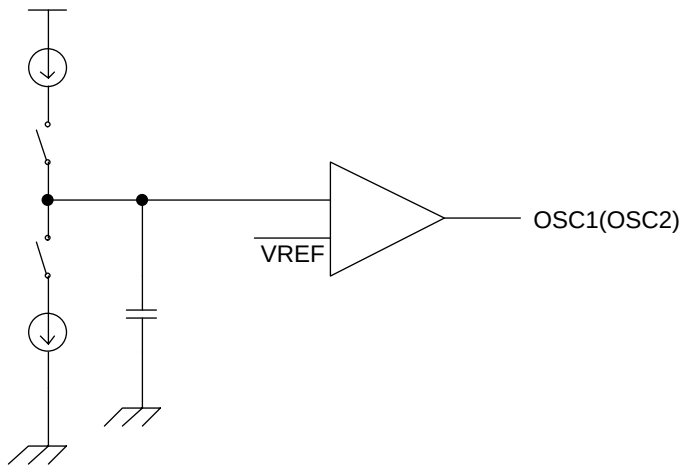


Figure 26. Oscillator Block Diagram

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

I/O



ELECTRICAL CHARACTERISTICS

$V_B = 12\text{ V}$, $T_A = -40^\circ\text{C}$ to 125°C (unless otherwise specified)

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNITS
INPUT BUFFER 1						
V _{IH}	Input threshold logic high		0.7 × V _{CC}			V
V _{IL}	Input threshold logic low		0.3 × V _{CC}			V
R _u	Input pullup resistance		50	100	150	kΩ
R _d	Input pulldown resistance		50	100	150	kΩ
OUTPUT BUFFER 1 AND 2						
V _{OH}	Output level logic high	I _{sink} = 2.5 mA	0.9 × V _{CC}			V
V _{OL}	Output level logic low	I _{source} = 2.5 mA	0.1 × V _{CC}			V
OUTPUT BUFFER 3						
R_RES	Pullup resistor		1.5	3	4.5	kΩ
V _{OL}	Output level logic low	I _{source} = 2 mA	0.1 × V _{CC}			V

ERROR DETECTION

Table 4. Error Detection

ITEMS	SPI	PRE-DRIVER	FAULT SIGNAL	$\overline{RES}$
V_B – Overvoltage	–	STOP	L	H
CP – Overvoltage	–	STOP	L	H
CP – Undervoltage	Error Bit (CPLV)	–	L	H
V_{CC} – Overvoltage	Error Bit (VCO)	–	L	H
V_{CC} – Undervoltage	–	STOP	L	L
V_{CC} – Overcurrent	Error Bit (V_{CC})	–	H	H
Motor – Overcurrent	Error Bit (OVAD)	STOP	H	H
V_{DD} – Overvoltage	Error Bit (VDO)	–	L	H
V_{DD} – Undervoltage	–	STOP	L	L
Thermal Shut Down	Error Bit (TD)	STOP	H	H
Watchdog	–	–	L	L
EEPROM Data Check	Error Bit (EEP)	–	L	H
Clock Monitor	–	–	L	L
SPI	Error Bit (SPI)	–	L	H

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp (3)	Op Temp (°C)	Top-Side Markings (4)	Samples
DRV3211QPFPQ1	ACTIVE	HTQFP	PFP	80	96	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR	-40 to 125	DRV3211	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check <http://www.ti.com/productcontent> for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

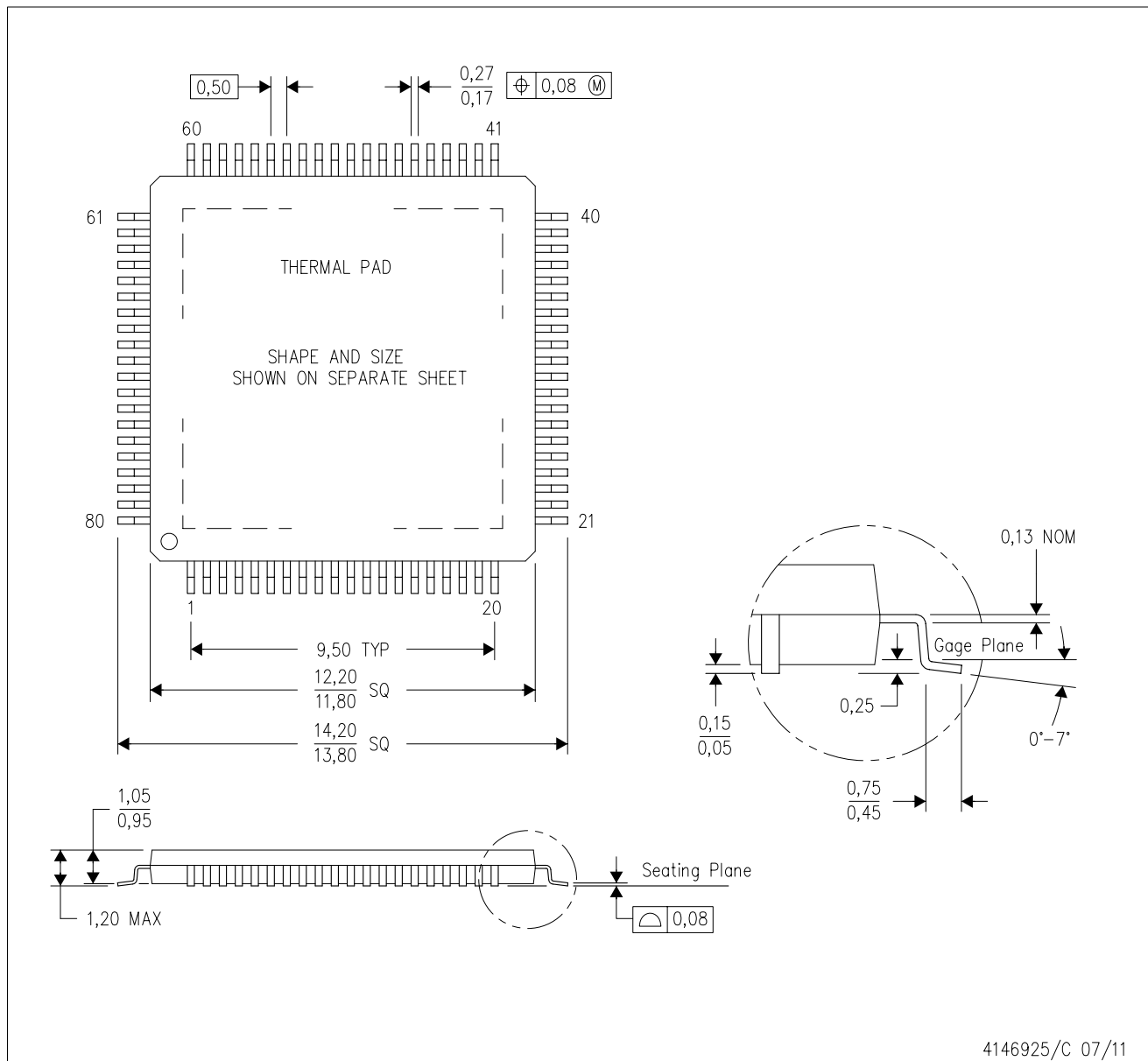
(4) Only one of markings shown within the brackets will appear on the physical device.

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PFP (S-PQFP-G80)

PowerPAD™ PLASTIC QUAD FLATPACK



- NOTES:
- A. All linear dimensions are in millimeters.
 - B. This drawing is subject to change without notice.
 - C. Body dimensions do not include mold flash or protrusion.
 - D. This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 for information regarding recommended board layout. This document is available at www.ti.com <<http://www.ti.com>>.
 - E. See the additional figure in the Product Data Sheet for details regarding the exposed thermal pad features and dimensions.
 - F. Falls within JEDEC MS-026

PowerPAD is a trademark of Texas Instruments.

THERMAL PAD MECHANICAL DATA

PFP (S-PQFP-G80)

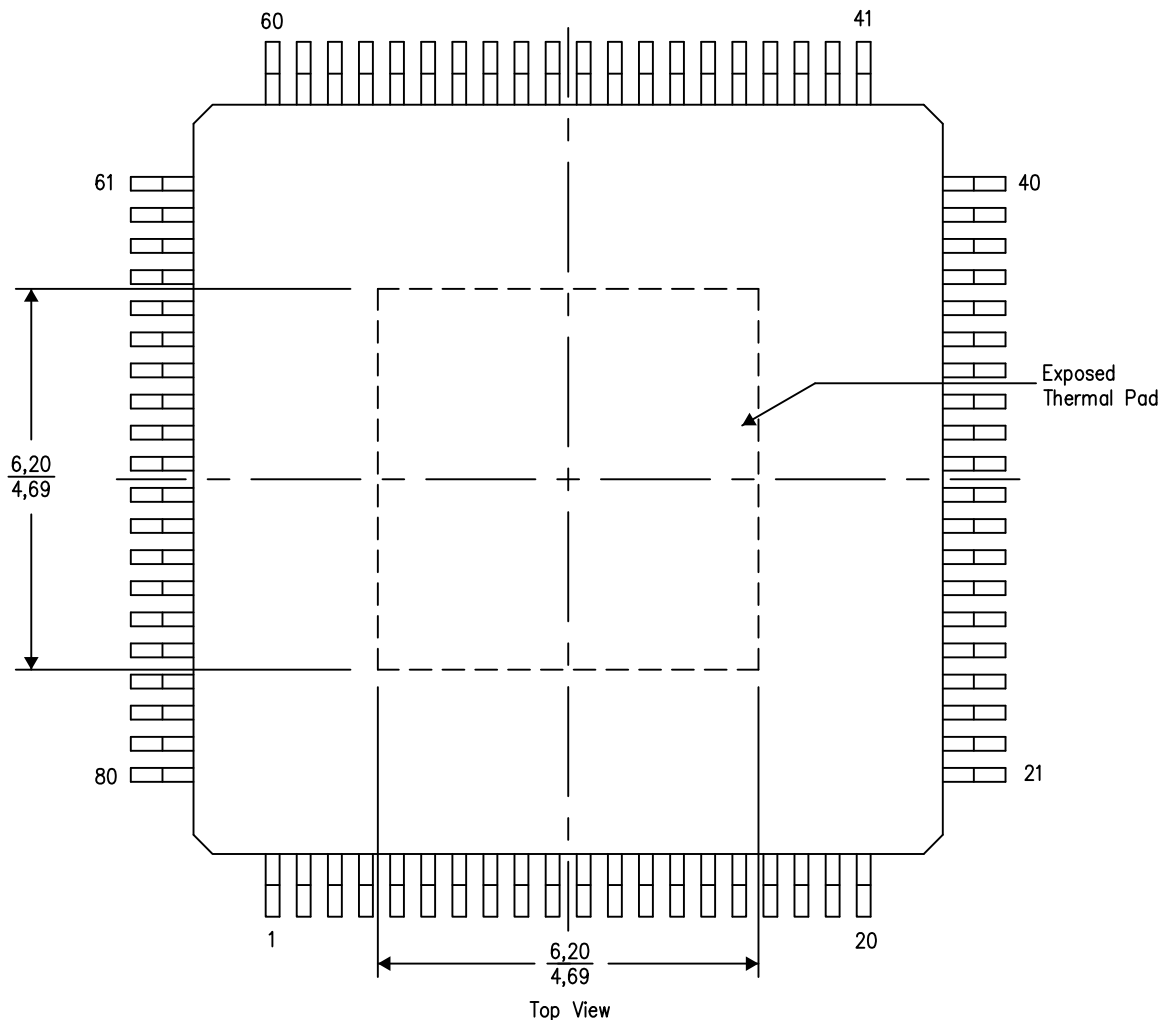
PowerPAD™ PLASTIC QUAD FLATPACK

THERMAL INFORMATION

This PowerPAD™ package incorporates an exposed thermal pad that is designed to be attached to a printed circuit board (PCB). The thermal pad must be soldered directly to the PCB. After soldering, the PCB can be used as a heatsink. In addition, through the use of thermal vias, the thermal pad can be attached directly to the appropriate copper plane shown in the electrical schematic for the device, or alternatively, can be attached to a special heatsink structure designed into the PCB. This design optimizes the heat transfer from the integrated circuit (IC).

For additional information on the PowerPAD package and how to take advantage of its heat dissipating abilities, refer to Technical Brief, PowerPAD Thermally Enhanced Package, Texas Instruments Literature No. SLMA002 and Application Brief, PowerPAD Made Easy, Texas Instruments Literature No. SLMA004. Both documents are available at www.ti.com.

The exposed thermal pad dimensions for this package are shown in the following illustration.



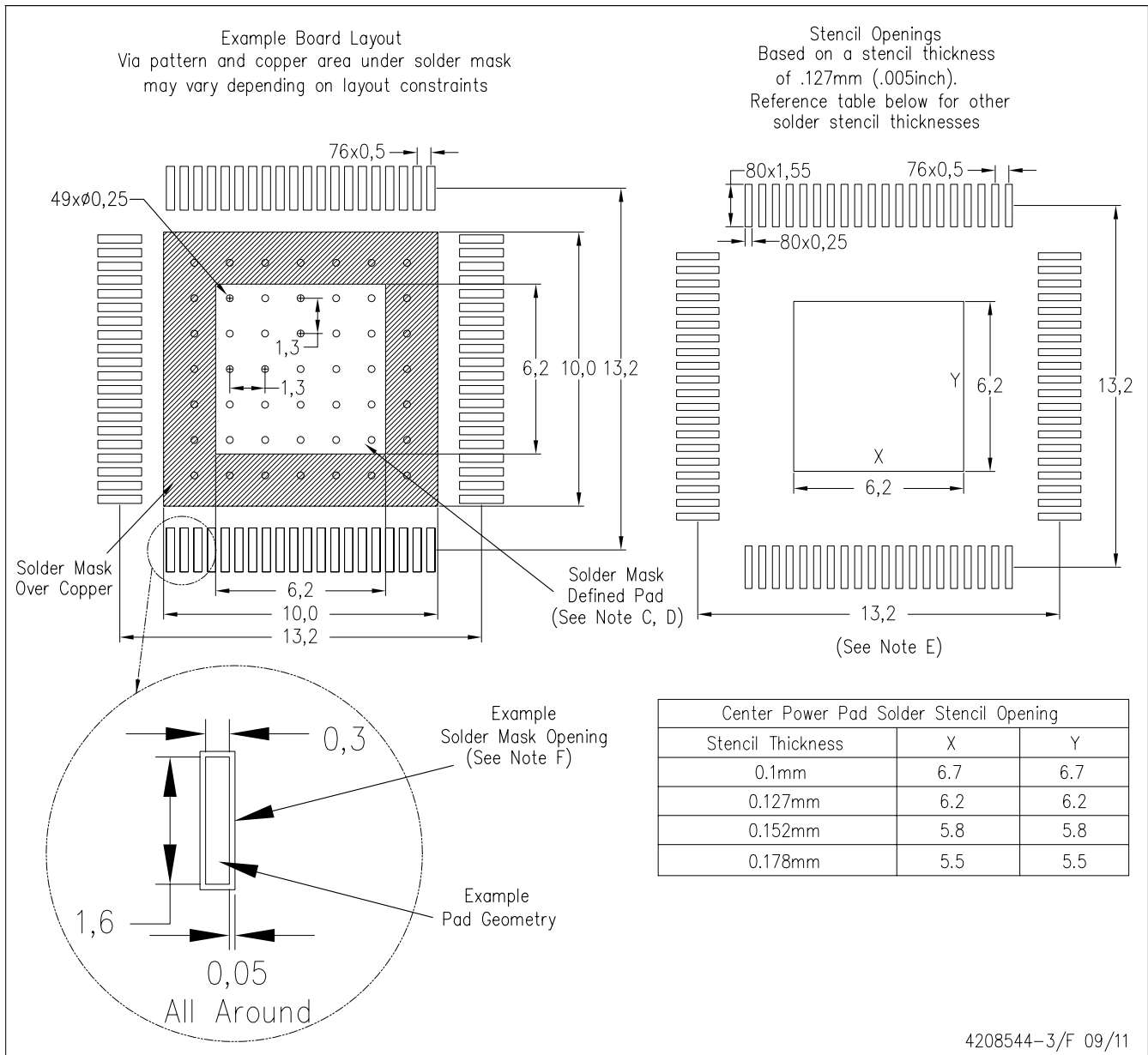
4206327-3/0 07/12

NOTE: A. All linear dimensions are in millimeters

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PFP (S-PQFP-G80)

PowerPAD™ PLASTIC QUAD FLATPACK



- NOTES:
- All linear dimensions are in millimeters.
 - This drawing is subject to change without notice.
 - Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
 - This package is designed to be soldered to a thermal pad on the board. Refer to Technical Brief, PowerPad Thermally Enhanced Package, Texas Instruments Literature No. SLMA002, SLMA004, and also the Product Data Sheets for specific thermal information, via requirements, and recommended board layout. These documents are available at www.ti.com <<http://www.ti.com>>. Publication IPC-7351 is recommended for alternate designs.
 - Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.
 - Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

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